SAR Test Report

For

Applicant Name:	**Shanghai Notion Information Technology CO. LTD**
Address:	Room 408, Building 2, Lane 666, Zhangheng Rd, Pudong New Area, Shanghai, China
EUT Name:	LTE Wireless Router/LTE Mobile Wifi/LTE MiFi/4G MIFI
Model Number:	M281T
Series Model Number:	M27, M271, M271s, M271T, M271Ts, M272, M272s, M272T, M272Ts, M28, M281, M281s, M281Ts, M29, M291, M291T, M291s, M291Ts, L28I, L27I, M281e, M271e, M291e, M6

Issued By

Company Name:	**BTF Testing Lab (Shenzhen) Co., Ltd.**
Address:	F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China
Report Number:	BTF240605R00501
Test Standards:	FCC 47 CFR§2.1093 IEC/IEEE 62209-1528: 2020 IEEE C95.1-2019 KDB447498 D04 KDB865664 D01 KDB865664 D02 KDB941225 D01 KDB941225 D05 KDB248227 D01 KDB941225 D06 KDB648474 D04 KDB690783 D01
FCC ID:	2AR45-M281T
Test Conclusion:	Pass
Test Date:	2024-06-05 to 2024-06-12
Date of Issue:	2024-06-13
Prepared By:	Amenda Zhong
	Amenda Zhong / Project Engineer
Date:	2024-06-13
Approved By:	Ryan.CJ
	Ryan.CJ / EMC Manager
Date:	2024-06-13

Note: All the test results in this report only related to the testing samples. Which can be duplicated completely for the legal use with approval of applicant; it shall not be reproduced except in full without the written approval of BTF Testing Lab (Shenzhen) Co., Ltd., All the objections should be raised within thirty days from the date of issue. To validate the report, you can contact us.

Revision History		
Version	Issue Date	Revisions Content
R_V0	2024-06-13	Original
Note:	*Once the revision has been made, then previous versions reports are invalid.*	

Table of Contents

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

1. Introduction

1.1 Identification of Testing Laboratory

Company Name:	BTF Testing Lab (Shenzhen) Co., Ltd.
Address:	F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China
Phone Number:	+86-0755-23146130
Fax Number:	+86-0755-23146130

1.2 Identification of the Responsible Testing Location

Test Location:	BTF Testing Lab (Shenzhen) Co., Ltd.
Address:	F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China
Description:	All measurement facilities used to collect the measurement data are located at F101,201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China
FCC Registration Number	518915
Designation Number	CN1330

1.3 Laboratory Condition

Ambient Temperature:	21℃ to 25℃
Ambient Relative Humidity:	48% to 59%
Ambient Pressure:	100 kPa to 102 kPa

1.4 Announcement

(1) The test report reference to the report template version v0.

(2) The test report is invalid if not marked with the signatures of the persons responsible for preparing, reviewing and approving the test report.

(3) The test report is invalid if there is any evidence and/or falsification.

(4) This document may not be altered or revised in any way unless done so by BTF and all revisions are duly noted in the revisions section.

(5) Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.

(6) The laboratory is only responsible for the data released by the laboratory, except for the part provided by the applicant.

2. Product Information

2.1 Application Information

Company Name:	Shanghai Notion Information Technology CO. LTD
Address:	Room 408, Building 2, Lane 666, Zhangheng Rd, Pudong New Area, Shanghai, China

2.2 Manufacturer Information

Company Name:	Shanghai Notion Information Technology CO. LTD
Address:	Room 408, Building 2, Lane 666, Zhangheng Rd, Pudong New Area, Shanghai, China

2.3 Factory Information

Company Name:	Shanghai Notion Information Technology CO. LTD
Address:	Room 408, Building 2, Lane 666, Zhangheng Rd, Pudong New Area, Shanghai, China

2.4 General Description of Equipment under Test (EUT)

EUT Name	LTE Wireless Router/LTE Mobile Wifi/LTE MiFi/4G MIFI
Under Test Model Name	M281T
Series Model Name	M27, M271, M271s, M271T, M271Ts, M272, M272s, M272T, M272Ts, M28, M281, M281s, M281Ts, M29, M291, M291T, M291s, M291Ts, L28I, L27I, M281e, M271e, M291e, M6
Description of Model name differentiation	Only the model and appearance is different, others are the same.
Sample No.	BTFSN240605006/1 E1

2.5 Equipment under Test Ancillary Equipment

Ancillary Equipment 1	Rechargeable Battery	
	Capacity	3000mAh
	Rated Voltage	3.8V

2.6 Technical Information

Network and Wireless connectivity	3G Network WCDMA/HSDPA/HSUPA Band 2/4/5 4G Network FDD LTE Band 2/4/5/7/38/41 2.4G WIFI 802.11b, 802.11g, 802.11n(HT20/40)

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

The requirement for the following technical information of the EUT was tested in this report:

Operating Mode	WCDMA, LTE, WLAN		
Frequency Range	WCDMA Band 2	TX: 1850 ~ 1910 MHz	RX: 1930 ~ 1990 MHz
	WCDMA Band 4	TX: 1710 ~ 1755 MHz	RX: 2110 ~ 2155 MHz
	WCDMA Band 5	TX: 824 ~ 849 MHz	RX: 869 ~ 894 MHz
	LTE Band 2	TX: 1850 ~ 1910 MHz	RX: 1930 ~ 1990 MHz
	LTE Band 4	TX: 1710 ~ 1755 MHz	RX: 2110 ~ 2155 MHz
	LTE Band 5	TX: 824 ~ 849 MHz	RX: 869 ~ 894 MHz
	LTE Band 7	Tx: 2500 ~ 2570 MHz	Rx: 2620 ~ 2690 MHz
	LTE Band 38	2570 ~ 2620 MHz	
	LTE Band 41	2535 ~ 2655 MHz	
	802.11b/g/n(HT20)	2412 ~ 2462 MHz	
	802.11n(HT40)	2422 ~ 2452 MHz	
Antenna Type	WWAN: Internal Antenna WLAN: Internal Antenna		
Hotspot Function	Support		
Power Reduction	Not Support		
Exposure Category	General Population/Uncontrolled exposure		
EUT Stage	Portable Device		
Product	Type		
	☐ Production unit	☒ Identical prototype	

3. Summary of Test Results

3.1 Test Standards

No.	Identity	Document Title
1	47 CFR Part 2.1093	Radiofrequency radiation exposure evaluation: portable devices
2	IEC/IEEE 62209-1528: 2020	Measurement procedure for the assessment of specific absorption rate of human exposure to radio frequency fields from hand-held and body-mounted wireless communication devices - Part 1528: Human models, instrumentation, and procedures (Frequency range of 4 MHz to 10 GHz)
3	IEEE C95.1-2019	IEEE Standard for Safety Levels with Respect to Human Exposure to Electric, Magnetic, and Electromagnetic Fields, 0 Hz to 300 GHz
4	KDB 447498 D04	Interim General RF Exposure Guidance v01
5	KDB 865664 D01	SAR measurement 100MHz to 6GHz v01r04
6	KDB 865664 D02	RF Exposure Reporting v01r02
7	KDB941225 D01	3G SAR Procedures v03r01
8	KDB941225 D05	SAR for LTE Devices v02r05
9	KDB248227 D01	802.11 Wi-Fi SAR v02r02
10	KDB941225 D06	Hotspot Mode v02r01
11	KDB648474 D04	Handset SAR v01r03
12	KDB690783 D01	SAR Listings on Grant v01r03

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

3.2 Device Category and SAR Limit

This device belongs to portable device category because its radiating structure is allowed to be used within 20 centimeters of the body of the user. Limit for General Population/Uncontrolled exposure should be applied for this device, it is 1.6 W/kg as averaged over any 1 gram of tissue.

Body Position	SAR Value (W/Kg)	
	General Population/ Uncontrolled Exposure	Occupational/ Controlled Exposure
Whole-Body SAR (averaged over the entire body)	0.08	0.4
Partial-Body SAR (averaged over any 1 gram of tissue)	1.60	8.0
SAR for hands, wrists, feet and ankles (averaged over any 10 grams of tissue)	4.0	20.0

NOTE:
General Population/Uncontrolled Exposure: Locations where there is the exposure of individuals who have no knowledge or control of their exposure. General population/uncontrolled exposure limits are applicable to situations in which the general public may be exposed or in which persons who are exposed as a consequence of their employment may not be made fully aware of the potential for exposure or cannot exercise control over their exposure. Members of the general public would come under this category when exposure is not employment- related; for example, in the case of a wireless transmitter that exposes persons in its vicinity.

Occupational/Controlled Exposure: Locations where there is exposure that may be incurred by persons who are aware of the potential for exposure, In general, occupational/controlled exposure limits are applicable to situations in which persons are exposed as a consequence of their employment, who have been made fully aware of the potential for exposure and can exercise control over their exposure. This exposure category is also applicable when the exposure is of a transient nature due to incidental passage through a location where the exposure levels may be higher than the general population/uncontrolled limits, but the exposed person is fully aware of the potential for exposure and can exercise control over his or her exposure by leaving the area or by some other appropriate means.

3.3 Test Result Summary

The maximum results of Specific Absorption Rate (SAR) found during test as bellows:

<Highest Reported standalone SAR Summary>

Exposure Position	Frequency Band	Reported SAR (W/kg)	Equipment Class	Highest Reported SAR (W/kg)
Body(Hotspot) 1-g SAR (0 mm Gap)	WCDMA Band II	0.562	PCB	**0.798**
	WCDMA Band IV	0.521		
	WCDMA Band V	0.559		
	LTE Band 2	0.595		
	LTE Band 4	0.720		
	LTE Band 5	**0.798**		
	LTE Band 7	0.787		
	LTE Band 38	0.463		
	LTE Band 41	0.439		
	WLAN 2.4 GHz	0.515	DTS	

This device is in compliance with Specific Absorption Rate(SAR) for general population/uncontrolled exposure limits (1.6 W/kg) specified in FCC47 CFR part 2(2.1093) and ANSI/IEEE C95.1-2019, and had been tested in accordance with the measurement methods and procedures specified in IEC/IEEE 62209-1528: 2020.

<Highest Reported Simultaneous SAR>

Exposure Position	Simultaneous Configuration	Highest Reported Simultaneous Transmission SAR (W/kg)	Limit (W/kg)	Verdict
Body(Hotspot) 1-g SAR (0 mm Gap)	LTE Band 5 +2.4G WIFI	1.313	1.6	Pass

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

3.4 Test Uncertainty

3.4.1 Measurement uncertainly evaluation for SAR test

Measurement uncertainly evaluation for SAR test (300MHz to 6GHz)

Uncertainty Component	Tol (+- %)	Prob. Dist.	Div.	Ci (1g)	Ci (10g)	1g Ui (+- %)	10 g Ui (+-%)	Vi veff
Measurement System								
Probe calibration	5.8	N	1	1	1	5.80	5.80	∞
Axial Isotropy	3.5	R	√3	√0.5	√0.5	1.43	1.43	∞
Hemispherical Isotropy	5.9	R	√3	√0.5	√0.5	2.41	2.41	∞
Boundary effect	1.0	R	√3	1	1	0.58	0.58	∞
Linearity	4.7	R	√3	1	1	2.71	2.71	∞
System detection limits	1.0	R	√3	1	1	0.58	0.58	∞
Modulation response	3.0	R	√3	1	1	1.73	1.73	∞
Readout Electronics	0.5	N	1	1	1	0.50	0.50	∞
Response Time	0	R	√3	1	1	0.00	0.00	∞
Integration Time	1.4	R	√3	1	1	0.81	0.81	∞
RF ambient Conditions - Noise	3.0	R	√3	1	1	1.73	1.73	∞
RF ambient Conditions - Reflections	3.0	R	√3	1	1	1.73	1.73	∞
Probe positioner Mechanical Tolerance	1.4	R	√3	1	1	0.81	0.81	∞
Probe positioning with respect to Phantom Shell	1.4	R	√3	1	1	0.81	0.81	∞
Extrapolation, interpolation and integration Algorithms for Max. SAR Evaluation	2.3	R	√3	1	1	1.33	1.33	∞
Test sample Related								
Test sample positioning	2.6	N	1	1	1	2.60	2.60	11
Device Holder Uncertainty	3.0	N	1	1	1	3.00	3.00	7
Output power Variation - SAR drift measurement	5.0	R	√3	1	1	2.89	2.89	∞
SAR scaling	2.0	R	√3	1	1	1.15	1.15	∞
Phantom and Tissue Parameters								
Phantom Shell Uncertainty - Shape,Thickness and Permittivity	4	R	√3	1	1	2.31	2.31	∞
Uncertainty in SAR correction for deviation in permittivity and conductivity	2.0	N	1	1	0.84	2.00	1.68	∞
Liquid conductivity measurement	4.0	N	1	0.78	0.71	3.12	2.84	5
Liquid permittivity measurement	5.0	N	1	0.23	0.26	1.15	1.30	5
Liquid Conductivity - Temperature Uncertainty	2.5	R	√3	0.78	0.71	1.13	1.02	∞
Liquid permittivity - Temperature Uncertainty	2.5	R	√3	0.23	0.26	0.33	0.38	∞
Combined Standard Uncertainty		RSS				10.47	10.34	
Expanded Uncertainty (95% Confidence interval)		k				20.95	20.69	

* This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

3.4.2 Measurement uncertainly evaluation for system check

Uncertainty Component	Tol (+- %)	Prob. Dist.	Div.	Ci (1g)	Ci (10 g)	1g Ui (+- %)	10 g Ui (+-%)	Vi veff
Measurement System								
Probe calibration	5.8	N	1	1	1	5.80	5.80	∞
Axial Isotropy	3.5	R	√3	1	1	2.02	2.02	∞
Hemispherical Isotropy	5.9	R	√3	0	0	0.00	0.00	∞
Boundary effect	1	R	√3	1	1	0.58	0.58	∞
Linearity	4.7	R	√3	1	1	2.71	2.71	∞
System detection limits	1	R	√3	1	1	0.58	0.58	∞
Modulation response	0	N	√3	0	0	0.00	0.00	∞
Readout Electronics	0.5	N	1	1	1	0.50	0.50	∞
Response Time	0	R	√3	0	0	0.00	0.00	∞
Integration Time	1.4	R	√3	0	0	0.00	0.00	∞
RF ambient Conditions - Noise	3	R	√3	1	1	1.73	1.73	∞
RF ambient Conditions - Reflections	3	R	√3	1	1	1.73	1.73	∞
Probe positioner Mechanical Tolerance	1.4	R	√3	1	1	0.81	0.81	∞
Probe positioning with respect to Phantom Shell	1.4	R	√3	1	1	0.81	0.81	∞
Extrapolation, interpolation and integration Algorithms for Max. SAR Evaluation	2.3	R	√3	1	1	1.33	1.33	∞
Dipole								
Deviation of experimental source from numerical source	5	N	1	1	1	5.00	5.00	∞
Input Power and SAR driftmeasurement	0.5	R	√3	1	1	0.29	0.29	∞
Dipole Axis to Liquid Dist.	2.0	R	√3	1	1	1.15	1.15	∞
Phantom and Tissue Parameters								
Phantom Shell Uncertainty - Shape,Thickness and Permittivity	4	R	√3	1	1	2.31	2.31	∞
Uncertainty in SAR correction for deviation in permittivity and conductivity	2.0	N	1	1	0.84	2.00	1.68	∞
Liquid conductivity measurement	4	N	1	0.78	0.71	3.12	2.84	5
Liquid permittivity measurement	5.0	N	1	0.23	0.26	1.15	1.30	5
Liquid Conductivity - Temperature Uncertainty	2.5	R	√3	0.78	0.71	1.13	1.02	∞
Liquid permittivity - Temperature Uncertainty	2.5	R	√3	0.23	0.26	0.33	0.38	∞
Combined Standard Uncertainty		RSS				10.16	10.03	
Expanded Uncertainty (95% Confidence interval)		k				20.32	20.06	

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

4. Measurement System

4.1 Specific Absorption Rate (SAR) Definition

SAR is related to the rate at which energy is absorbed per unit mass in an object exposed to a radio field. The SAR distribution in a biological body is complicated and is usually carried out by experimental techniques or numerical modeling. The standard recommends limits for two tiers of groups, occupational/controlled and general population/uncontrolled, based on a person's awareness and ability to exercise control over his or her exposure. In general, occupational/controlled exposure limits are higher than the limits for general population/uncontrolled.

The SAR definition is the time derivative (rate) of the incremental energy (dW) absorbed by (dissipated in) an incremental mass (dm) contained in a volume element (dv) of a given density (ρ). The equation description is as below:

$$\mathbf{SAR} = \frac{d}{dt}\left(\frac{dW}{dm}\right) = \frac{d}{dt}\left(\frac{dW}{\rho dv}\right)$$

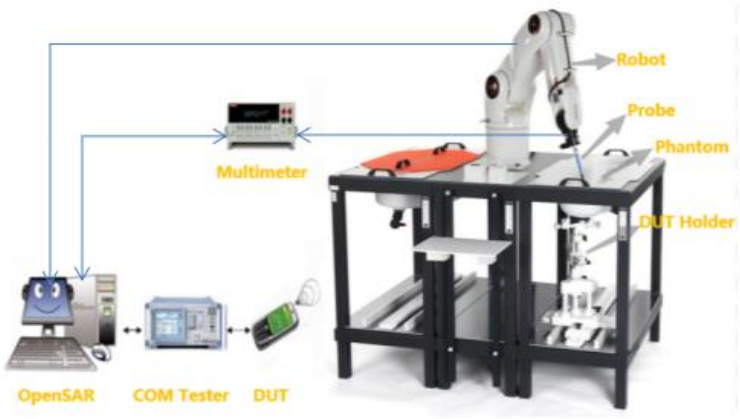
SAR is expressed in units of Watts per kilogram (W/kg) SAR measurement can be related to the electrical field in the tissue by

$$\mathbf{SAR} = \frac{\sigma E^2}{\rho}$$

Where: σ is the conductivity of the tissue,
ρ is the mass density of the tissue and E is the RMS electrical field strength.

4.2 MVG SAR System

4.2.1 SAR system diagram



4.2.2 Robot

A standard high precision 6-axis robot (Denso) with teaches pendant with Scanning System
· It must be able to scan all the volume of the phantom to evaluate the tridimensional distribution of SAR.
· Must be able to set the probe orthogonal of the surface of the phantom (±30°).
· Detects stresses on the probe and stop itself if necessary to keep the integrity of the probe.

4.2.3 E-Field Probe

For the measurements, the Specific Dosimetric SSE2 E-Field Probe with following specifications is used:

- Dynamic range: 0.01-100 W/kg
- Tip diameter: 2mm for SSE2
- Distance between probe tip and sensor centre: 1mm for SSE2
- Distance between sensor centre and the inner phantom surface: 2mm for f>=4GHz.
- Probe linearity: <0.25dB.
- Axial Isotropy: <0.25dB.
- Spherical Isotropy: <0.50dB.
- Calibration range: 150 to 6000 MHz for head & body simulating liquid
- Angle between probe axis (evaluation axis) and surface normal line: less than 20°.

4.2.4 Phantoms

SAM Phantom

For the measurements the Specific Anthropomorphic Mannequin (SAM) defined by the IEEE SCC-34/SC2 group is used. The probe scanning of the E-Field is done in the 2 halves of the normalized head. The normalized shape of the phantom corresponds to the dimensions of 90% of an adult head size. It enables the dosimetric evaluation of left and right-hand phone usage and includes an additional flat phantom part for the simplified body performance check.The phantom set-up includes a cover, which prevents the evaporation of the liquid.

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

The thickness of the phantom amounts to 2 mm±0.2 mm. The materials for the phantom do not affect the radiation of the device under test (DUT) : εr' <5
The head is filled with tissue simulating liquid. The hand do not have to be modeled.

SAM Phantom

TWIN SAM phantom			
	Mechanical	Electrical	
Overall thickness	2±0.2 mm(except ear area)	Relative permittivity	3.4
Dimensions	1000 mm(L) x 500 mm(W) x 200 mm(H)	Loss tangent	0.02
Maximum volume	27 L		
Material	Fiberglass based		

ELLIPTICAL Phantom

The phantom is for Body performance check filled with tissue-equivalent liquid to a depth of at least 150 mm, whose shell material is resistant to damage or reaction with tissue-equivalent liquid chemicals.

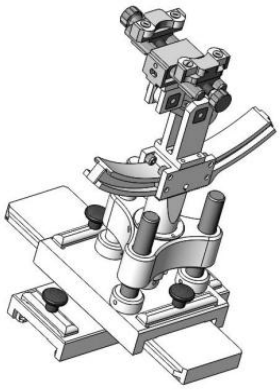
The shape of the phantom is an ellipse with length 600mm±5mm and width 400mm±5mm.
The phantom shell is made of low-loss and low-permittivity material, having loss tangent tanδ ≤ 0.05 and relative permittivity:
εr' ≤ 5 for f ≤ 3 GHz
3 ≤εr' ≤ 5 for f > 3 GHz
The thickness of the bottom-wall of the flat phantom is 2.0 mm with a tolerance of ± 0.2 mm.

ELLI Phantom

Technical & mechanical characteristics	
Shell thickness	2 mm ± 0.2 mm
Filling volume	25 L
Dimensions	600 mm x 400 mm x 200mm
Permittivity	4.4
Loss tangent	0.017

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

4.2.5 Device Holder



System Material	Permittivity	Loss tangent
Delrin	3.7	0.005

(The positioning system allows obtaining cheek and tilting position with a very good accuracy. In compliance with CENELEC, the tilt angle uncertainty is lower than 1°.)

System Material	Permittivity	Loss tangent
PMMA	2.9	0.028

4.2.6 Simulating Liquid

For SAR measurement of the field distribution inside the phantom, the phantom must be filled with homogeneous tissue simulating liquid to a depth of at least 15 cm. For head SAR testing, the liquid height from the ear reference point (ERP) of the phantom to the liquid top surface is larger than 15 cm. For body SAR testing, the liquid height from the center of the flat phantom to the liquid top surface is larger than 15 cm. The nominal dielectric values of the tissue simulating liquids in the phantom and the tolerance of 5%.

Head Liquid Depth	Body Liquid Depth
	

The following table gives the recipes for tissue simulating liquid and the theoretical Conductivity/Permittivity.

Head (Reference IEEE1528)								
Frequency (MHz)	Water (%)	Sugar (%)	Cellulose (%)	Salt (%)	Preventol (%)	DGBE (%)	Conductivity σ (S/m)	Permittivity ε
750	41.1	57.0	0.2	1.4	0.2	0	0.89	41.9
835	40.3	57.9	0.2	1.4	0.2	0	0.90	41.5
900	40.3	57.9	0.2	1.4	0.2	0	0.97	41.5
1800, 1900, 2000	55.2	0	0	0.3	0	44.5	1.4	40.0
2450	55.0	0	0	0.1	0	44.9	1.80	39.2
2600	54.9	0	0	0.1	0	45.0	1.96	39.0
Frequency (MHz)	Water (%)	Hexyl Carbitol (%)			Triton X-100 (%)		Conductivity σ (S/m)	Permittivity ε
5200	62.52	17.24			17.24		4.66	36.0
5800	62.52	17.24			17.24		5.27	35.3
Body (From instrument manufacturer)								
Frequency (MHz)	Water (%)	Sugar (%)	Cellulose (%)	Salt (%)	Preventol (%)	DGBE (%)	Conductivity σ (S/m)	Permittivity ε
750	51.7	47.2	0	0.9	0.1	0	0.96	55.5
835	50.8	48.2	0	0.9	0.1	0	0.97	55.2
900	50.8	48.2	0	0.9	0.1	0	1.05	55.0
1800, 1900, 2000	70.2	0	0	0.4	0	29.4	1.52	53.3
2450	68.6	0	0	0.1	0	31.3	1.95	52.7
2600	68.2	0	0	0.1	0	31.7	2.16	52.5
Frequency(MHz)	Water	DGBE (%)			Salt (%)		Conductivity σ (S/m)	Permittivity ε
5200	78.60	21.40			/		5.30	49.00
5800	78.50	21.40			0.1		6.00	48.20

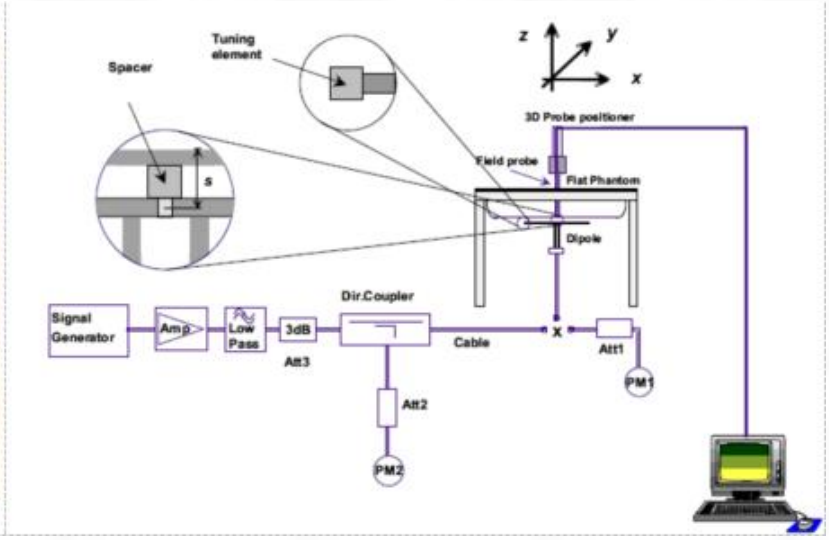
5. System Verification

5.1 Purpose of System Check

The system performance check verifies that the system operates within its specifications. System and operator errors can be detected and corrected. It is recommended that the system performance check be performed prior to any usage of the system in order to guarantee reproducible results. The system performance check uses normal SAR measurements in a simplified setup with a well characterized source. The setup was selected to give a high sensitivity to all parameters that might fail or vary over time. The system check does not intend to replace the calibration of the components, but indicates situations where the system uncertainty is exceeded due to drift or failure.

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

5.2 System Check Setup



6. TEST POSITION CONFIGURATIONS

According to KDB 648474 D04 Handset, handsets are tested for SAR compliance in head, body-worn accessory and other use configurations described in the following subsections.

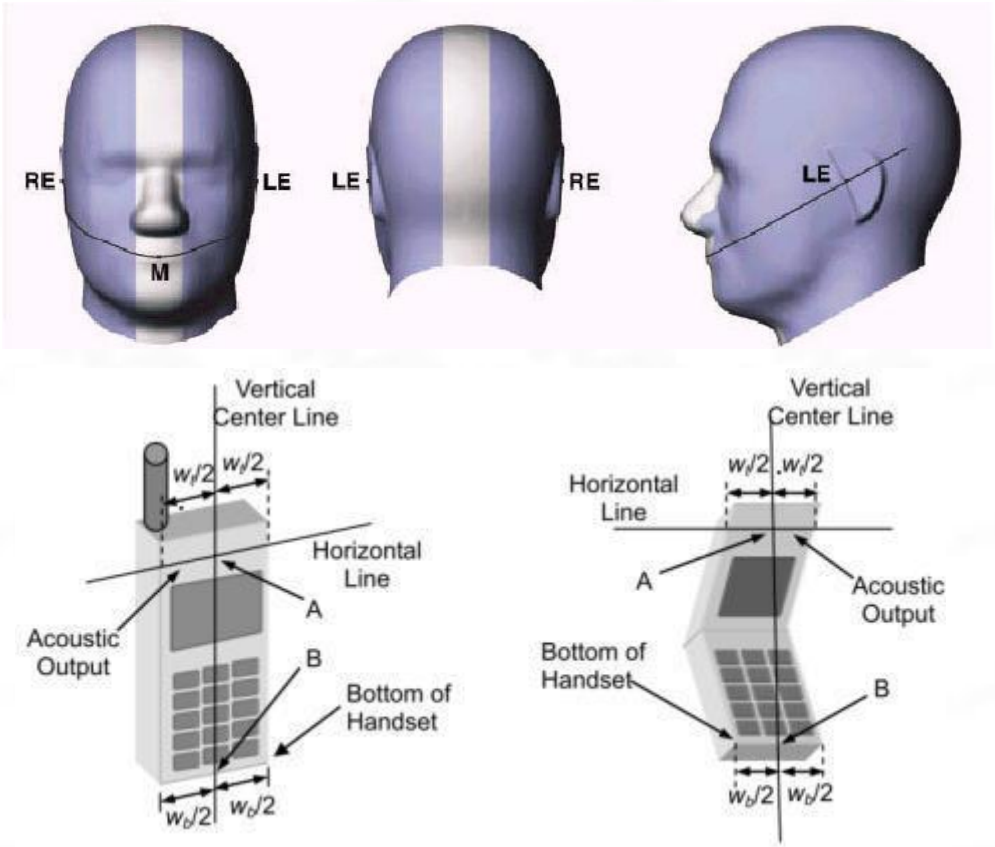
6.1 Head Exposure Conditions

Head exposure is limited to next to the ear voice mode operations. Head SAR compliance is tested according to the test positions defined in IEEE Std 1528-2013 using the SAM phantom illustrated as below.

6.1.1 Two Imaginary Lines on the Handset

(a) The vertical center line passes through two points on the front side of the handset - the midpoint of the width w t of the handset at the level of the acoustic output, and the midpoint of the width w b of the bottom of the handset.
(b) The horizontal line is perpendicular to the vertical center line and passes through the center of the acoustic output. The horizontal line is also tangential to the face of the handset at point A.
(c) The two lines intersect at point A. Note that for many handsets, point A coincides with the center of the acoustic output; however, the acoustic output may be located elsewhere on the horizontal line. Also note that the vertical center line is not necessarily parallel to the front face of the handset, especially for clamshell handsets, handsets with flip covers, and other irregularly shaped handsets.

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China



6.1.2 Two Imaginary Lines on the Handset

(a) To position the device with the vertical center line of the body of the device and the horizontal line crossing the center piece in a plane parallel to the sagittal plane of the phantom. While maintaining the device in this plane, align the vertical center line with the reference plane containing the three ear and mouth reference point (M: Mouth, RE: Right Ear, and LE: Left Ear) and align the center of the ear piece with the line RE-LE.

(b) To move the device towards the phantom with the ear piece aligned with the line LE-RE until the phone touched the ear. While maintaining the device in the reference plane and maintaining the phone contact with the ear, move the bottom of the phone until any point on the front side is in contact with the cheek of the phantom or until contact with the ear is lost.

6.1.3 Titled Position

(a) To position the device in the “cheek” position described above.

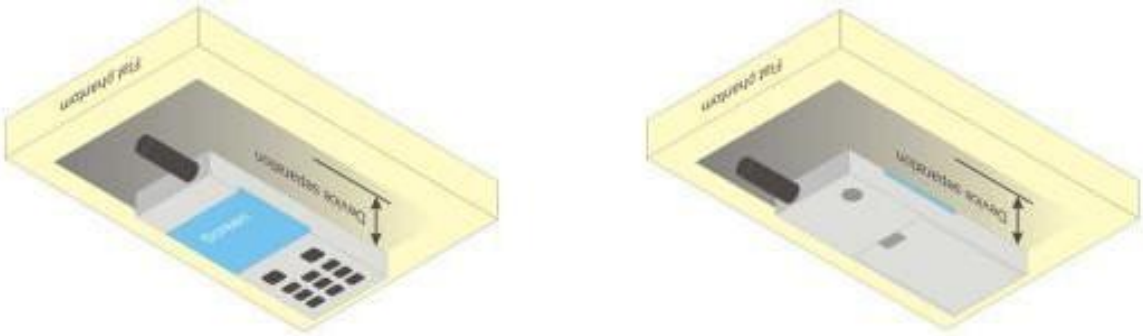
(b) While maintaining the device the reference plane described above and pivoting against the ear, moves it outward away from the mouth by an angle of 15 degrees or until contact with the ear is lost.

6.2 Body-worn Position Conditions

Body-worn accessory exposure is typically related to voice mode operations when handsets are carried in body-worn accessories. The body-worn accessory procedures in KDB 447498 are used to test for body-worn accessory SAR compliance, without a headset connected to it. This enables the test results for such configuration to be compatible with that required for hotspot mode when the body-worn accessory test separation distance is greater than or equal to that required for hotspot mode. When the reported SAR for a body-worn accessory.

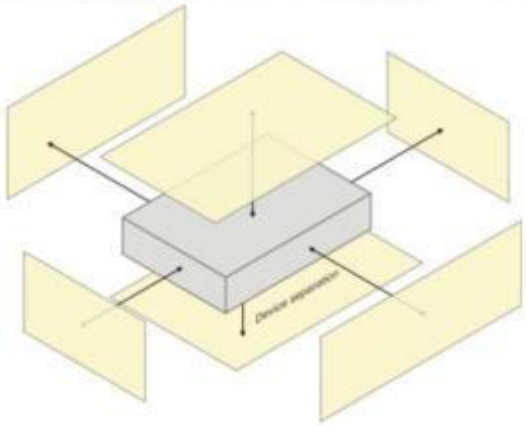
Body-worn accessories that do not contain metallic or conductive components may be tested according to worst-case exposure configurations, typically according to the smallest test separation distance required for the group of body-worn accessories with similar operating and exposure characteristics. All body-worn accessories containing metallic components are tested in conjunction with the host device.

Body-worn accessory SAR compliance is based on a single minimum test separation distance for all wireless and operating modes applicable to each body-worn accessory used by the host, and according to the relevant voice and/or data mode transmissions and operations. If a body-worn accessory supports voice only operations in its normal and expected use conditions, testing of data mode for body-worn compliance is not required. A conservative minimum test separation distance for supporting off-the-shelf body-worn accessories that may be acquired by users of consumer handsets is used to test for body-worn accessory SAR compliance. This distance is determined by the handset manufacturer, according to the requirements of Supplement C 01-01. Devices that are designed to operate on the body of users using lanyards and straps, or without requiring additional body-worn accessories, will be tested using a conservative minimum test separation distance <= 5 mm to support compliance.



6.3 Hotspot Mode Exposure Position Conditions

For handsets that support hotspot mode operations, with wireless router capabilities and various web browsing functions, the relevant hand and body exposure conditions are tested according to the hotspot SAR procedures in KDB 941225. A test separation distance of 10 mm is required between the phantom and all surfaces and edges with a transmitting antenna located within 25 mm from that surface or edge. When the form factor of a handset is smaller than 9 cm x 5 cm, a test separation distance of 5 mm (instead of 10 mm) is required for testing hotspot mode. When the separation distance required for body-worn accessory testing is larger than or equal to that tested for hotspot mode, in the same wireless mode and for the same surface of the phone, the hotspot mode SAR data may be used to support body-worn accessory SAR compliance for that particular configuration (surface).



6.4 Product Specific 10g Exposure Consideration

According with FCC KDB 648474 D04, for smart phones with a display diagonal dimension > 15.0 cm or an overall diagonal dimension > 16.0 cm that provide similar mobile web access and multimedia support found in mini-tablets or UMPC mini-tablets that support voice calls next to the ear, unless it is confirmed otherwise through KDB inquiries, the following phablet procedures should be applied to evaluate SAR compliance for each applicable wireless modes and frequency band. Devices marketed as phablets, regardless of form factors and operating characteristics must be tested as a phablet to determine SAR compliance;

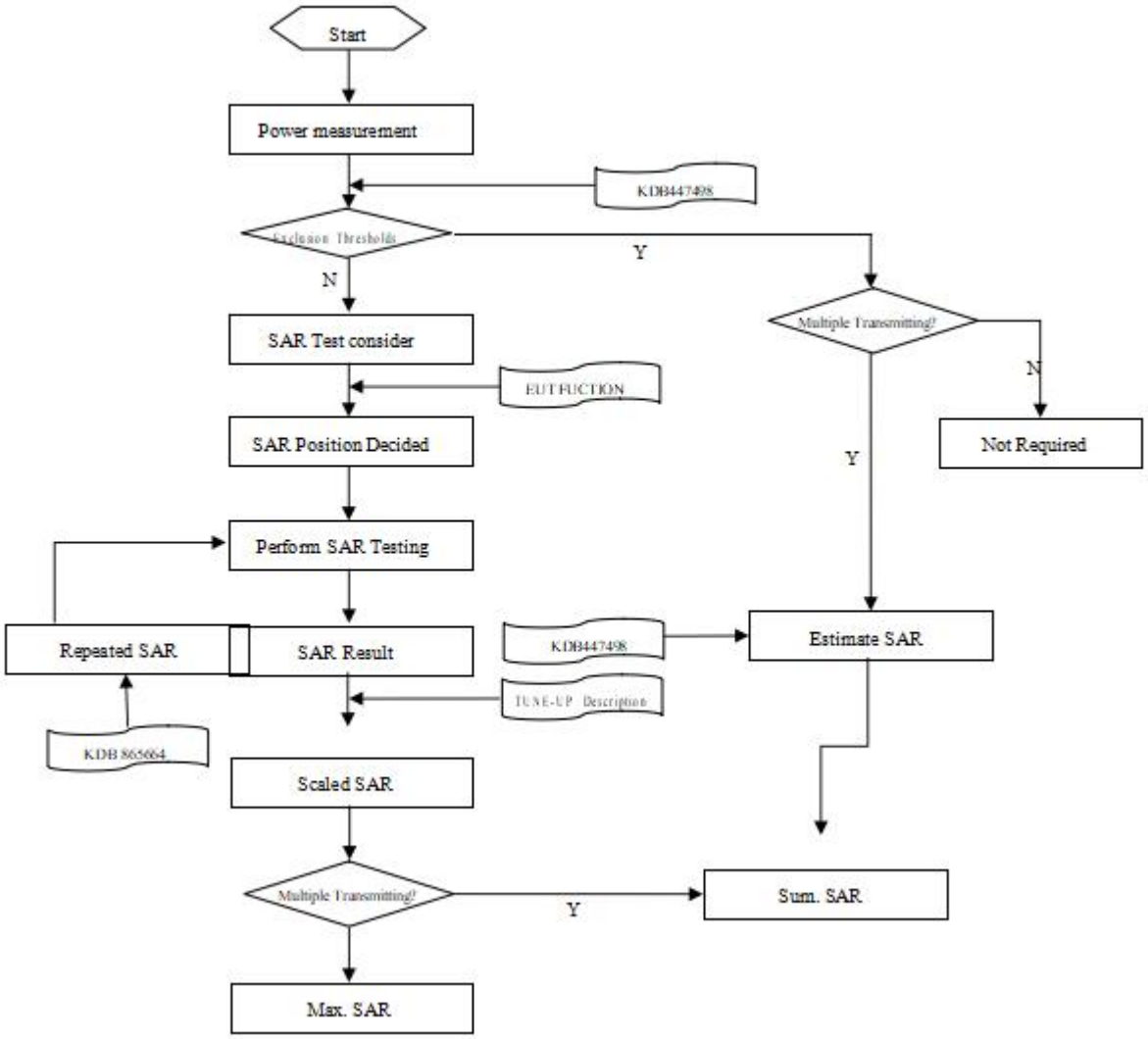
The UMPC mini-tablet procedures must also be applied to test the SAR of all surfaces and edges with an antenna located at ≤ 25 mm from that surface or edge, in direct contact with a flat phantom, for 10-g extremity SAR according to the body-equivalent tissue dielectric parameters in KDB 865664 to address interactive hand use exposure conditions. The UMPC mini-tablet 1-g SAR at 5 mm is not required. When hotspot mode applies, 10-g extremity SAR is required only for the surfaces and edges with hotspot mode 1-g reported SAR > 1.2 W/kg.

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

7. Measurement Procedure

7.1 Measurement Process Diagram

Body SAR



7.2 SAR Scan General Requirement

Probe boundary effect error compensation is required for measurements with the probe tip closer than half a probe tip diameter to the phantom surface. Both the probe tip diameter and sensor offset distance must satisfy measurement protocols; to ensure probe boundary effect errors are minimized and the higher fields closest to the phantom surface can be correctly measured and extrapolated to the phantom surface for computing 1 g SAR. Tolerances of the post-processing algorithms must be verified by the test laboratory for the scan resolutions used in the SAR measurements, according to the reference distribution functions specified in IEC/IEEE 62209-1528: 2020.

Table 3 – Area scan parameters

Parameter	DUT transmit frequency being tested	
	$f \leq 3$ GHz	3 GHz < $f \leq 10$ GHz
Maximum distance between the measured points (geometric centre of the sensors) and the inner phantom surface (z_{M1} in Figure 20 in mm)	5 ± 1	$\delta \ln(2)/2 \pm 0,5$ [a]
Maximum spacing between adjacent measured points in mm (see O.8.3.1)[b]	20, or half of the corresponding zoom scan length, whichever is smaller	$60/f$, or half of the corresponding zoom scan length, whichever is smaller
Maximum angle between the probe axis and the phantom surface normal (α in Figure 20)[c]	5° (flat phantom only) 30° (other phantoms)	5° (flat phantom only) 20° (other phantoms)
Tolerance in the probe angle	1°	1°

[a] δ is the penetration depth for a plane-wave incident normally on a planar half-space.

[b] See Clause O.8 on how Δx and Δy may be selected for individual area scan requirements.

[c] The probe angle relative to the phantom surface normal is restricted due to the degradation in the measurement accuracy in fields with steep spatial gradients. The measurement accuracy decreases with increasing probe angle and increasing frequency. This is the reason for the tighter probe angle restriction at frequencies above 3 GHz.

Table 4 – Zoom scan parameters

Parameter	DUT transmit frequency being tested	
	$f \leq 3$ GHz	3 GHz < $f \leq 10$ GHz
Maximum distance between the closest measured points and the phantom surface (z_{M1} in Figure 20 and Table 3, in mm)	5	$\delta \ln(2)/2$ [a]
Maximum angle between the probe axis and the phantom surface normal (α in Figure 20)	5° (flat phantom only) 30° (other phantoms)	5° (flat phantom only) 20° (other phantoms)
Maximum spacing between measured points in the x- and y-directions (Δx and Δy, in mm)	8	$24/f$ [b]
For uniform grids: Maximum spacing between measured points in the direction normal to the phantom shell (Δz_1 in Figure 20, in mm)	5	$10/(f - 1)$
For graded grids: Maximum spacing between the two closest measured points in the direction normal to the phantom shell (Δz_1 in Figure 20, in mm)	4	$12/f$
For graded grids: Maximum incremental increase in the spacing between measured points in the direction normal to the phantom shell ($R_z = \Delta z_2/\Delta z_1$ in Figure 20)	1,5	1,5
Minimum edge length of the zoom scan volume in the x- and y-directions (L_z in O.8.3.2, in mm)	30	22
Minimum edge length of the zoom scan volume in the direction normal to the phantom shell (L_h in O.8.3.2 in mm)	30	22
Tolerance in the probe angle	1°	1°

[a] δ is the penetration depth for a plane-wave incident normally on a planar half-space.

[b] This is the maximum spacing allowed, which might not work for all circumstances.

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

7.3 Measurement Procedure

The following steps are used for each test position

a. Establish a call with the maximum output power with a base station simulator. The connection between the mobile and the base station simulator is established via air interface

b. Measurement of the local E-field value at a fixed location. This value serves as a reference value for calculating a possible power drift.

c. Measurement of the SAR distribution with a grid of 8 to 16mm * 8 to16 mm and a constant distance to the inner surface of the phantom. Since the sensors cannot directly measure at the inner phantom surface, the values between the sensors and the inner phantom surface are extrapolated. With these values the area of the maximum SAR is calculated by an interpolation scheme.

d. Around this point, a cube of 30 * 30 * 30 mm or 32 * 32 *32 mm is assessed by measuring 5 or 8 * 5 or 8*4 or 5 mm. With these data, the peak spatial-average SAR value can be calculated.

7.4 Area & Zoom Scan Procedure

First Area Scan is used to locate the approximate location(s) of the local peak SAR value(s). The measurement grid within an Area Scan is defined by the grid extent, grid step size and grid offset. Next, in order to determine the EM field distribution in a three-dimensional spatial extension, Zoom Scan is required. The Zoom Scan is performed around the highest E-field value to determine the averaged SAR-distribution over 10 g. Area scan and zoom scan resolution setting follows KDB 865664 D01v01r04 quoted below.

When the 1 g SAR of the highest peak is within 2 dB of the SAR limit, additional zoom scans are required for other peaks within 2 dB of the highest peak that have not been included in any zoom scan to ensure there is no increase in SAR.

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

8. Conducted RF Output Power

8.1 WCDMA

Mode		Maximum Tune-up(dBm)	WCDMA Band II		
			Conducted Power (dBm)		
			CH9262	CH9400	CH9538
			1852.4	1880.0	1907.6
RMC 12.2K		**24.50**	24.00	23.70	**24.33**
HSDPA	Subtest-1	24.50	24.26	24.16	24.27
	Subtest-2	24.00	23.68	23.60	23.80
	Subtest-3	23.50	23.16	23.20	23.41
	Subtest-4	23.50	23.13	23.12	23.41
HSUPA	Subtest-1	26.00	25.64	25.87	25.93
	Subtest-2	25.00	24.19	24.56	24.90
	Subtest-3	26.50	25.44	26.15	25.80
	Subtest-4	25.50	24.92	25.40	25.33
	Subtest-5	27.50	26.82	27.47	26.07
Mode		Maximum Tune-up(dBm)	WCDMA Band IV		
			Conducted Power (dBm)		
			CH1312	CH1413	CH1513
			1712.4	1732.6	1752.6
RMC 12.2K		**26.00**	25.33	24.55	**25.64**
HSDPA	Subtest-1	26.50	25.86	26.01	26.25
	Subtest-2	26.00	25.47	25.13	25.91
	Subtest-3	26.00	25.27	24.47	25.56
	Subtest-4	26.00	25.21	24.41	25.55
HSUPA	Subtest-1	24.00	23.64	23.27	23.94
	Subtest-2	22.00	21.73	21.46	21.97
	Subtest-3	23.00	22.15	22.31	22.86
	Subtest-4	22.50	21.52	21.57	22.14
	Subtest-5	25.00	24.38	23.74	24.61
Mode		Maximum Tune-up(dBm)	WCDMA Band V		
			Conducted Power (dBm)		
			CH4132	CH4182	CH4233
			826.4	836.4	846.6
RMC 12.2K		**28.50**	27.84	**28.14**	28.00
HSDPA	Subtest-1	28.50	27.74	28.01	27.92
	Subtest-2	27.50	26.85	27.22	27.12
	Subtest-3	27.00	26.32	26.82	26.62
	Subtest-4	27.00	26.28	26.79	26.60
HSUPA	Subtest-1	27.50	26.82	27.19	27.03
	Subtest-2	26.00	25.07	25.73	25.72
	Subtest-3	27.00	25.83	26.24	26.52
	Subtest-4	26.00	25.12	25.93	25.83
	Subtest-5	28.00	27.46	27.73	27.61

Per KDB 941225 D01, when the maximum output power and tune-up tolerance specified for production units in a secondary mode is ≤1/2dB higher than the primary mode (RMC12.2kbps) or when the highest reported SAR of the primary mode is scaled by the ratio of specified maximum output power and tune-up tolerance of secondary to primary mode and the adjusted SAR is ≤ 1.2 W/kg, SAR measurement is not required for the secondary mode.

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

8.2 LTE

Band 2

LTE-FDD Band 2				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		18607	18900	19193
					1850.7MHz	1880.0MHz	1909.3MHz
1.4MHz	QPSK	1	0	23.50	23.20	23.28	23.43
			2	23.50	23.20	23.27	23.04
			5	23.50	23.23	23.30	22.59
		3	0	23.50	23.22	23.24	22.92
			2	23.50	23.22	23.33	22.79
			3	23.50	23.22	23.31	22.51
		6	0	22.50	22.30	22.39	22.48
	16QAM	1	0	23.00	22.44	22.43	22.55
			2	22.50	22.45	22.43	22.33
			5	22.50	22.45	22.49	22.41
		3	0	22.50	22.11	22.08	22.15
			2	22.50	22.11	22.08	21.92
			3	22.50	22.13	22.12	22.10
		6	0	21.50	21.22	21.30	21.46
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	18615	18900	19185
					1851.5MHz	1880.0MHz	1908.5MHz
3MHz	QPSK	1	0	23.50	23.09	23.17	23.43
			7	23.50	23.07	23.11	23.39
			14	23.50	23.09	23.14	23.37
		8	0	22.50	22.14	22.23	22.47
			4	22.50	22.13	22.21	22.45
			7	22.50	22.11	22.21	22.43
		15	0	22.50	22.15	22.23	22.44
	16QAM	1	0	23.00	22.25	22.38	22.62
			7	23.00	22.23	22.31	22.55
			14	23.00	22.24	22.35	22.50
		8	0	22.00	21.24	21.35	21.62
			4	22.00	21.24	21.31	21.56
			7	22.00	21.23	21.30	21.55
		15	0	22.00	21.18	21.22	21.50
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	18625	18900	19175
					1852.5MHz	1880.0MHz	1907.5MHz
5MHz	QPSK	1	0	23.50	23.07	23.15	23.45
			12	23.50	23.03	23.12	23.36
			24	23.50	23.05	23.20	23.27
		12	0	23.00	22.16	22.24	22.53
			6	22.50	22.15	22.23	22.49
			13	22.50	22.15	22.23	22.49
		25	0	23.00	22.15	22.22	22.53
	16QAM	1	0	22.50	22.07	22.13	22.43
			12	22.50	22.06	22.11	22.41
			24	22.50	22.05	22.16	22.30
		12	0	22.00	21.17	21.29	21.54
			6	22.00	21.18	21.28	21.53
			13	22.00	21.22	21.34	21.51
		25	0	22.00	21.24	21.31	21.58

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

LTE-FDD Band 2				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		18650	18900	19150
					1855.0MHz	1880.0MHz	1905.0MHz
10MHz	QPSK	1	0	23.50	23.15	23.21	23.40
			25	23.50	23.10	23.16	23.42
			49	23.50	23.13	23.21	23.44
		25	0	23.00	22.15	22.25	22.54
			13	23.00	22.18	22.20	22.54
			25	23.00	22.14	22.25	22.53
		50	0	23.00	22.17	22.26	22.50
	16QAM	1	0	23.00	22.33	22.43	22.59
			25	23.00	22.30	22.39	22.65
			49	23.00	22.30	22.45	22.59
		25	0	22.00	21.21	21.30	21.61
			13	22.00	21.21	21.29	21.59
			25	22.00	21.22	21.29	21.57
		50	0	22.00	21.22	21.31	21.61
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	18675	18900	19125
					1857.5MHz	1880.0MHz	1902.5MHz
15MHz	QPSK	1	0	23.50	23.10	23.24	23.37
			38	23.50	23.11	23.17	23.43
			74	23.50	23.16	23.23	23.45
		36	0	22.50	22.19	22.36	22.49
			18	23.00	22.20	22.28	22.58
			39	23.00	22.23	22.32	22.58
		75	0	23.00	22.20	22.31	22.59
	16QAM	1	0	23.00	22.30	22.46	22.53
			38	23.00	22.31	22.36	22.62
			74	23.00	22.29	22.43	22.60
		36	0	22.00	21.23	21.33	21.52
			18	22.00	21.20	21.32	21.61
			39	22.00	21.22	21.29	21.65
		75	0	22.00	21.26	21.38	21.61
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	18700	18900	19100
					1860.0MHz	1880.0MHz	1900.0MHz
20MHz	QPSK	1	0	23.50	23.04	23.19	23.28
			50	23.50	23.02	23.14	23.34
			99	**23.50**	23.04	23.18	**23.39**
		50	0	22.50	22.15	22.30	22.43
			25	22.50	22.16	22.30	22.48
			50	23.00	22.16	22.27	**22.55**
		100	0	23.00	22.16	22.27	22.51
	16QAM	1	0	22.50	21.89	22.09	22.14
			50	22.50	21.93	22.00	22.22
			99	22.50	21.90	22.05	22.29
		50	0	21.50	21.15	21.32	21.42
			25	21.50	21.18	21.30	21.48
			50	22.00	21.18	21.31	21.58
		100	0	22.00	21.19	21.29	21.50

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

Band 4

LTE-FDD Band 4				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		19957	20175	20393
					1710.7MHz	1732.5MHz	1754.3MHz
1.4MHz	QPSK	1	0	24.00	23.38	23.54	23.37
			2	24.00	23.38	23.54	23.37
			5	24.00	23.40	23.56	23.37
		3	0	24.00	23.36	23.56	23.42
			2	24.00	23.38	23.58	23.40
			3	24.00	23.38	23.57	23.40
		6	0	23.00	22.45	22.61	22.41
	16QAM	1	0	23.00	22.68	22.82	22.62
			2	23.00	22.60	22.79	22.66
			5	23.00	22.68	22.83	22.58
		3	0	23.00	22.50	22.44	22.21
			2	23.00	22.50	22.44	22.26
			3	23.00	22.51	22.42	22.25
		6	0	22.00	21.46	21.55	21.37
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	19965	20175	20385
					1711.5MHz	1732.5MHz	1753.5MHz
3MHz	QPSK	1	0	24.00	23.42	23.57	23.44
			7	24.00	23.35	23.50	23.37
			14	24.00	23.35	23.53	23.32
		8	0	23.00	22.45	22.63	22.48
			4	23.00	22.43	22.60	22.43
			7	23.00	22.44	22.59	22.45
		15	0	23.00	22.46	22.61	22.45
	16QAM	1	0	23.00	22.62	22.76	22.68
			7	23.00	22.61	22.74	22.60
			14	23.00	22.62	22.70	22.56
		8	0	22.00	21.59	21.74	21.59
			4	22.00	21.58	21.72	21.58
			7	22.00	21.59	21.71	21.55
		15	0	22.00	21.51	21.66	21.50
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	19975	20175	20375
					1712.5MHz	1732.5MHz	1752.5MHz
5MHz	QPSK	1	0	24.00	23.35	23.50	23.44
			13	23.50	23.34	23.46	23.38
			24	23.50	23.40	23.45	23.30
		12	0	23.00	22.44	22.60	22.47
			6	23.00	22.43	22.57	22.44
			13	23.00	22.43	22.57	22.41
		25	0	23.00	22.41	22.58	22.40
	16QAM	1	0	23.00	22.33	22.52	22.41
			13	22.50	22.35	22.45	22.33
			24	22.50	22.33	22.47	22.27
		12	0	22.00	21.51	21.68	21.55
			6	22.00	21.53	21.65	21.50
			13	22.00	21.51	21.60	21.47
		25	0	22.00	21.55	21.68	21.56

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

LTE-FDD Band 4				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		20000	20175	20350
					1715.0MHz	1732.5MHz	1750.0MHz
10MHz	QPSK	1	0	24.00	23.40	23.58	23.50
			25	24.00	23.39	23.50	23.39
			49	23.50	23.43	23.48	23.27
		25	0	23.00	22.46	22.62	22.52
			13	23.00	22.48	22.59	22.47
			25	23.00	22.48	22.58	22.42
		50	0	23.00	22.46	22.57	22.45
	16QAM	1	0	23.00	22.65	22.80	22.77
			25	23.00	22.62	22.70	22.64
			49	23.00	22.66	22.64	22.51
		25	0	22.00	21.56	21.68	21.58
			13	22.00	21.54	21.65	21.55
			25	22.00	21.56	21.62	21.49
		50	0	22.00	21.57	21.68	21.58
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	20025	20175	20325
					1717.5MHz	1732.5MHz	1747.5MHz
15MHz	QPSK	1	0	24.00	23.45	23.57	23.55
			38	24.00	23.43	23.51	23.44
			74	23.50	23.46	23.43	23.27
		38	0	23.00	22.55	22.67	22.70
			18	23.00	22.58	22.63	22.60
			37	23.00	22.57	22.62	22.53
		75	0	23.00	22.53	22.61	22.57
	16QAM	1	0	23.00	22.64	22.79	22.80
			38	23.00	22.64	22.73	22.68
			74	23.00	22.68	22.66	22.50
		38	0	22.00	21.57	21.67	21.65
			18	22.00	21.55	21.67	21.63
			37	22.00	21.63	21.64	21.54
		75	0	22.00	21.61	21.69	21.65
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	20050	20175	20300
					1720.0MHz	1732.5MHz	1745.0MHz
20MHz	QPSK	1	0	**24.00**	23.42	**23.55**	23.54
			50	23.50	23.40	23.49	23.43
			99	23.50	23.41	23.38	23.22
		50	0	23.00	22.54	**22.64**	22.66
			25	23.00	22.54	22.59	22.55
			50	23.00	22.58	22.52	22.43
		100	0	23.00	22.54	22.59	22.55
	16QAM	1	0	23.00	22.34	22.85	22.41
			50	23.00	22.25	22.81	22.29
			99	23.00	22.25	22.62	22.05
		50	0	22.00	21.58	21.78	21.62
			25	22.00	21.59	21.73	21.57
			50	22.00	21.59	21.66	21.48
		100	0	22.00	21.57	21.67	21.57

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

Band 5

LTE-FDD Band 5				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		20407	20525	20643
					824.7MHz	836.5MHz	848.3MHz
1.4MHz	QPSK	1	0	24.00	23.52	23.51	23.34
			2	24.00	23.51	23.50	23.35
			5	24.00	23.50	23.50	23.36
		3	0	24.00	23.50	23.56	23.36
			2	24.00	23.51	23.55	23.38
			3	24.00	23.52	23.54	23.36
		6	0	23.00	22.55	22.51	22.40
	16QAM	1	0	23.00	22.74	22.68	22.57
			2	23.00	22.73	22.73	22.61
			5	23.00	22.76	22.66	22.60
		3	0	23.00	22.62	22.40	22.41
			2	23.00	22.61	22.34	22.45
			3	23.00	22.60	22.33	22.41
		6	0	22.00	21.58	21.44	21.38
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	20415	20525	20635
					825.5MHz	836.5MHz	847.5MHz
3MHz	QPSK	1	0	24.00	23.60	23.53	23.43
			7	24.00	23.54	23.45	23.40
			14	24.00	23.53	23.44	23.42
		8	0	23.00	22.61	22.57	22.46
			4	23.00	22.61	22.58	22.46
			7	23.00	22.60	22.58	22.44
		15	0	23.00	22.61	22.59	22.44
	16QAM	1	0	23.00	22.68	22.68	22.70
			7	23.00	22.70	22.64	22.70
			14	23.00	22.70	22.63	22.67
		8	0	22.00	21.71	21.68	21.46
			4	22.00	21.69	21.68	21.45
			7	22.00	21.72	21.66	21.45
		15	0	22.00	21.63	21.58	21.48

LTE-FDD Band 5				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		20425	20525	20625
					826.5MHz	836.5MHz	846.5MHz
5MHz	QPSK	1	0	24.00	23.51	23.52	23.44
			13	23.50	23.48	23.46	23.39
			24	23.50	23.49	23.47	23.40
		12	0	23.00	22.62	22.59	22.45
			6	23.00	22.59	22.58	22.46
			13	23.00	22.58	22.54	22.43
		25	0	23.00	22.61	22.56	22.45
	16QAM	1	0	23.00	22.48	22.46	22.59
			13	23.00	22.42	22.40	22.57
			24	23.00	22.47	22.40	22.59
		12	0	22.00	21.62	21.64	21.55
			6	22.00	21.64	21.62	21.53
			13	22.00	21.62	21.57	21.53
		25	0	22.00	21.62	21.61	21.52

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	20450	20525	20600
					829.0MHz	836.5MHz	844.0MHz
10MHz	QPSK	1	0	**24.00**	**23.60**	23.59	23.51
			25	24.00	23.53	23.51	23.40
			49	24.00	23.54	23.43	23.35
		25	0	23.00	**22.63**	22.62	22.53
			13	23.00	22.62	22.59	22.50
			25	23.00	22.62	22.54	22.47
		50	0	23.00	22.61	22.56	22.50
	16QAM	1	0	23.00	22.78	22.79	22.74
			25	23.00	22.71	22.69	22.58
			49	23.00	22.70	22.62	22.56
		25	0	22.00	21.70	21.68	21.59
			13	22.00	21.70	21.61	21.53
			25	22.00	21.67	21.61	21.49
		50	0	22.00	21.72	21.64	21.60

Band 7

LTE-FDD Band 7				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		20775	21100	21425
					2502.5MHz	2535.0MHz	2567.5MHz
5MHz	QPSK	1	0	23.50	22.78	22.98	23.08
			12	23.50	22.75	22.99	23.01
			24	23.50	22.76	23.04	23.01
		12	0	22.50	21.93	22.10	22.13
			6	22.50	21.91	22.11	22.10
			13	22.50	21.90	22.13	22.09
		25	0	22.50	21.93	22.11	22.16
	16QAM	1	0	22.50	21.58	21.94	22.25
			12	22.50	21.54	21.94	22.24
			24	22.50	21.55	21.98	22.22
		12	0	21.50	20.84	21.12	21.21
			6	21.50	20.85	21.11	21.18
			13	21.50	20.84	21.11	21.14
		25	0	21.50	21.00	21.14	21.15
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	20800	21100	21400
					2505.0MHz	2535.0MHz	2565.0MHz
10MHz	QPSK	1	0	23.50	22.90	23.04	23.05
			24	23.50	22.80	23.02	22.98
			49	23.50	22.79	23.11	22.95
		25	0	22.50	21.94	22.10	22.18
			12	22.50	21.90	22.12	22.14
			25	22.50	21.94	22.15	22.13
		50	0	22.50	21.91	22.14	22.15
	16QAM	1	0	22.50	22.07	22.26	22.03
			24	22.50	21.98	22.29	21.93
			49	22.50	21.98	22.35	21.92
		25	0	21.50	20.94	21.10	21.17
			12	21.50	20.92	21.12	21.14
			25	21.50	20.92	21.17	21.12
		50	0	21.50	20.96	21.24	21.17

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

LTE-FDD Band 7				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		20825	21100	21375
					2507.5MHz	2535.0MHz	2562.5MHz
15MHz	QPSK	1	0	23.50	22.90	22.99	23.13
			38	23.50	22.83	23.01	23.08
			74	23.50	22.87	23.07	22.98
		38	0	22.50	22.01	22.15	22.20
			18	22.50	21.99	22.19	22.18
			37	22.50	22.00	22.20	22.14
		75	0	22.50	22.00	22.17	22.17
	16QAM	1	0	23.00	22.07	22.13	22.57
			38	23.00	22.00	22.21	22.50
			74	22.50	22.02	22.23	22.36
		38	0	21.50	20.99	21.12	21.20
			18	21.50	20.96	21.14	21.20
			37	21.50	20.98	21.16	21.18
		75	0	21.50	21.01	21.15	21.18
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	20850	21100	21350
					2510.0MHz	2535.0MHz	2560.0MHz
20MHz	QPSK	1	0	23.50	22.92	22.94	23.05
			49	23.50	22.86	23.02	23.02
			99	**23.50**	22.93	**23.07**	22.91
		50	0	22.50	22.03	22.14	22.20
			25	22.50	22.01	**22.20**	22.15
			50	22.50	22.03	22.20	22.09
		100	0	22.50	22.03	22.16	22.12
	16QAM	1	0	22.50	21.72	21.78	22.34
			49	22.50	21.68	21.87	22.36
			99	22.50	21.76	21.87	22.18
		50	0	21.50	20.97	21.09	21.30
			25	21.50	21.00	21.14	21.23
			50	21.50	20.98	21.18	21.19
		100	0	21.50	21.01	21.16	21.18

Band 38

LTE-TDD Band 38				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		37775	38000	38225
					2572.5MHz	2595.0MHz	2617.5MHz
5MHz	QPSK	1	0	23.50	23.08	23.01	22.97
			12	23.50	22.98	23.09	22.97
			24	23.50	22.93	23.08	22.98
		12	0	22.50	21.94	21.95	22.02
			6	22.00	21.95	21.97	22.00
			13	22.50	21.95	22.00	22.02
		25	0	22.50	21.99	22.02	22.03
	16QAM	1	0	22.50	22.21	22.11	22.05
			12	22.50	22.07	22.21	22.02
			24	22.50	21.96	22.30	22.05
		12	0	21.50	21.02	20.97	21.08
			6	21.50	20.95	21.01	21.12
			13	21.50	20.95	21.02	21.12
		25	0	21.50	20.95	21.06	20.99

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	37800	38000	38200
					2575.00MHz	2595.00MHz	2615.00MHz
10MHz	QPSK	1	0	23.50	23.06	22.98	23.02
			24	23.50	22.89	23.00	23.02
			49	23.50	23.00	23.07	23.05
		25	0	22.50	22.05	22.06	22.10
			12	22.50	21.97	22.09	22.11
			25	22.50	21.98	22.11	22.11
		50	0	22.50	22.05	22.10	22.11
	16QAM	1	0	23.00	22.61	22.50	21.90
			24	23.00	22.32	22.58	21.90
			49	23.00	22.55	22.64	21.96
		25	0	21.50	21.08	21.07	21.17
			12	21.50	21.04	21.09	21.10
			25	21.50	21.06	21.17	21.13
		50	0	21.50	21.06	21.05	21.11

LTE-TDD Band 38				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		37825	38000	38175
					2577.5MHz	2595.0MHz	2612.5MHz
15MHz	QPSK	1	0	23.00	23.00	23.00	22.92
			38	23.50	22.90	23.03	22.95
			74	23.50	22.93	23.06	22.95
		38	0	22.50	21.99	22.02	22.04
			18	22.50	21.97	22.06	22.03
			37	22.50	21.97	22.11	22.03
		75	0	22.50	21.97	22.03	22.10
	16QAM	1	0	23.00	22.52	22.55	22.14
			38	23.00	22.45	22.57	22.15
			74	23.00	22.46	22.56	22.19
		38	0	21.50	21.08	21.11	21.00
			18	21.50	21.05	21.15	21.03
			37	21.50	21.04	21.22	21.02
		75	0	21.50	21.00	21.08	21.17
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	37850	38000	38150
					2580.0MHz	2595.0MHz	2610.0MHz
20MHz	QPSK	1	0	23.50	23.03	22.80	22.99
			49	23.00	22.84	22.88	22.99
			99	**23.50**	22.92	22.96	**23.04**
		50	0	22.50	21.97	21.99	22.09
			25	22.50	21.96	22.05	22.12
			50	22.50	21.94	22.04	**22.13**
		100	0	22.50	21.93	22.06	22.08
	16QAM	1	0	22.50	21.99	22.05	21.82
			49	22.50	21.93	22.14	21.86
			99	22.50	21.94	22.18	21.87
		50	0	21.50	21.02	21.08	21.09
			25	21.50	20.99	21.10	21.09
			50	21.50	20.98	21.14	21.10
		100	0	21.50	20.97	21.05	21.04

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

Band 41

LTE-TDD Band 41				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		40065	40590	41215
					2537.5MHz	2590.0MHz	2652.5MHz
5MHz	QPSK	1	0	23.50	21.07	23.01	22.82
			13	23.00	22.50	22.99	21.74
			24	23.50	22.06	23.09	21.08
		12	0	22.50	21.55	22.05	21.92
			6	22.50	21.32	22.02	21.89
			13	22.50	21.22	22.07	21.48
		25	0	22.50	21.62	22.09	21.86
	16QAM	1	0	22.50	20.86	22.22	22.06
			13	22.50	20.96	22.24	22.30
			24	22.50	21.14	22.28	22.25
		12	0	21.50	19.76	21.06	20.88
			6	21.50	19.77	21.04	20.83
			13	21.50	19.88	21.06	20.84
		25	0	21.50	19.75	21.14	20.97
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	40090	40590	41190
					2540.0MHz	2590.0MHz	2650.0MHz
10MHz	QPSK	1	0	23.50	22.69	23.26	23.23
			24	23.50	22.39	23.24	23.02
			49	23.50	22.50	23.30	21.41
		25	0	22.50	21.23	22.21	22.16
			12	22.50	21.23	22.23	22.10
			25	22.50	21.43	22.25	22.04
		50	0	22.50	21.14	22.22	22.10
	16QAM	1	0	22.50	21.43	22.49	22.46
			24	22.50	21.57	22.46	22.28
			49	23.00	21.78	22.53	21.33
		25	0	21.50	20.46	21.29	21.21
			12	21.50	20.26	21.27	21.16
			25	21.50	20.37	21.31	21.15
		50	0	21.50	20.21	21.26	21.15

LTE-TDD Band 41				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		40115	40590	41165
					2542.5MHz	2590.0MHz	2647.5MHz
15MHz	QPSK	1	0	23.50	22.38	23.16	23.31
			38	23.50	22.52	23.20	23.07
			74	23.50	22.57	23.26	21.38
		38	0	22.50	21.16	22.20	22.26
			18	22.50	21.32	22.23	22.16
			37	22.50	21.47	22.22	22.06
		75	0	22.50	21.43	22.22	22.14
	16QAM	1	0	23.00	21.37	22.40	22.54
			38	22.50	21.66	22.39	22.30
			74	22.50	21.76	22.43	21.28
		38	0	21.50	20.18	21.21	21.31
			18	21.50	20.38	21.21	21.18
			37	21.50	20.49	21.25	21.09
		75	0	21.50	20.34	21.21	21.21

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	40140	40590	41140
					2545.0MHz	2590.0MHz	2645.0MHz
20MHz	QPSK	1	0	**23.50**	21.82	23.15	**23.44**
			50	23.50	22.48	23.14	23.14
			99	23.50	22.68	23.24	21.49
		50	0	22.50	21.33	22.18	**22.33**
			25	22.50	21.46	22.18	22.19
			50	22.50	21.59	22.23	22.04
		100	0	22.50	21.54	22.19	22.22
	16QAM	1	0	22.00	20.43	21.64	21.94
			50	22.00	20.77	21.68	21.71
			99	22.00	21.19	21.72	21.34
		50	0	21.50	20.31	21.21	21.41
			25	21.50	20.49	21.22	21.28
			50	21.50	20.63	21.28	21.08
		100	0	21.50	20.42	21.15	21.22

8.3 Wi-Fi

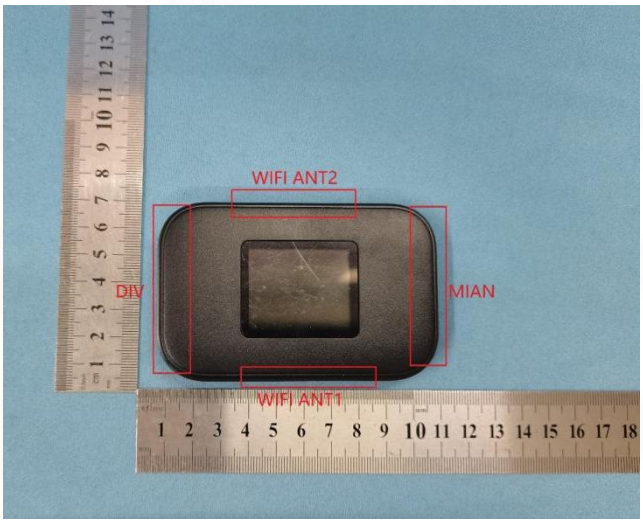
Ant. 1						
Band (GHz)	Mode	Channel	Freq. (MHz)	Average power(dBm)	Maximum Tune-up(dBm)	SAR Test Require.
2.4g (2.4~2.4835)	802.11b	1	2412	**16.78**	**17.00**	Yes
		7	2437	16.44	16.50	No
		13	2462	16.15	16.50	No
	802.11g	1	2412	16.63	17.00	No
		7	2437	16.38	16.50	No
		13	2462	16.30	16.50	No
	802.11n(HT20)	1	2412	**16.81**	**17.00**	Yes
		7	2437	16.56	17.00	No
		13	2462	15.63	16.00	No
	802.11n(HT40)	3	2422	15.74	16.00	No
		7	2437	15.79	16.00	No
		11	2452	15.77	16.00	No
Ant. 2						
Band (GHz)	Mode	Channel	Freq. (MHz)	Average power(dBm)	Maximum Tune-up(dBm)	SAR Test Require.
2.4g (2.4~2.4835)	802.11b	1	2412	**16.43**	**16.50**	Yes
		7	2437	15.49	15.50	No
		13	2462	15.42	15.50	No
	802.11g	1	2412	16.47	16.50	No
		7	2437	15.69	16.00	No
		13	2462	15.61	16.00	No
	802.11n(HT20)	1	2412	**16.72**	**17.00**	Yes
		7	2437	15.96	16.00	No
		13	2462	15.82	16.00	No
	802.11n(HT40)	3	2412	16.15	16.50	No
		7	2437	16.15	16.50	No
		11	2462	16.10	16.50	No
MIMO						
Band (GHz)	Mode	Channel	Freq. (MHz)	Average power(dBm)	Maximum Tune-up(dBm)	SAR Test Require.
2.4g (2.4~2.4835)	802.11n(HT20)	1	2412	**13.93**	**14.00**	Yes
		7	2437	13.20	13.50	No
		13	2462	13.20	13.50	No
	802.11n(HT40)	3	2412	13.73	14.00	No
		7	2437	13.16	13.50	No
		11	2462	13.44	13.50	No

Notes:
For WiFi 2.4GHz, SAR tests at higher order modulations (including 802.11g/n) were not required since the maximum average output power for each of these configurations is not more than 1/4dB higher than the tested channel for the lowest data rate of 802.11b mode; When 802.11g/n SAR test is required, 802.11g/n SAR was evaluated based on the highest 802.11b SAR configuration in each exposure condition.

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

9. Test Exclusion Consideration

Antenna information:



WWAN Antenna	WCDMA/LTE TX/RX
WLAN Antenna	WLAN TX/RX

Note:
1. KDB 447498 D04v01, the EUT is a portable router that can be carried in a pocket or held in a hand, so consider a minimum test separation distance of 0mm.
2. KDB 447498 D04v01, particular DUT edges were not required to be evaluated for SAR if the antenna-to-edge distance is greater than 2.5cm.
3. Per KDB648474 D04,10-g extremity SAR is not required when Body-Worn mode 1-g reported SAR<1.2W/Kg.

Distance of The Antenna to the EUT surface and edge (mm）						
Antenna	Front Side (mm)	Back Side (mm)	Left Edge (mm)	Right Edge (mm)	Top Edge (mm)	Bottom Edge (mm)
WWAN	<25	<25	<25	90	<25	<25
Wifi Ant.1	<25	<25	<25	<25	55	<25
Wifi Ant.2	<25	<25	<25	<25	<25	55
Positions for SAR tests						
Antenna	Front Side (mm)	Back Side (mm)	Left Edge (mm)	Right Edge (mm)	Top Edge (mm)	Bottom Edge (mm)
WWAN	Yes	Yes	Yes	No	Yes	Yes
Wifi Ant.1	Yes	Yes	Yes	Yes	No	Yes
Wifi Ant.2	Yes	Yes	Yes	Yes	Yes	No

9.1 SAR Test Exclusion Consideration Table

Per KDB 447498 requires when the standalone SAR test exclusion of section 4.3.1 is applied to an antenna that transmits simultaneously with other antennas, the standalone SAR must be estimated according to the following format to determine simultaneous transmission SAR test exclusion:

(max.power of channel, including tune-up tolerance, mW) / (min. test separation distance, mm)] · [√f(GHz) / x] W/kg for test separation distances ≤ 50 mm;
where x = 7.5 for 1-g SAR, and x= 18.75 for 10-g SAR.

0.4 W/Kg for 1-g SAR and 1.0 W/kg for 10-g SAR, when the test separation distances is > 50 mm

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

10. Test Result

Body												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas. SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
WCDMA Band 2 (RMC*)	Front	9538	1907.6	0.450	0.420	100.00	1.000	24.33	24.50	1.040	0.437	/
	Back	9538	1907.6	-2.780	0.540	100.00	1.000	24.33	24.50	1.040	**0.562**	1#
	Left	9538	1907.6	1.650	0.378	100.00	1.000	24.33	24.50	1.040	0.393	/
	Top	9538	1907.6	3.360	0.266	100.00	1.000	24.33	24.50	1.040	0.277	/
	Bottom	9538	1907.6	-1.740	0.251	100.00	1.000	24.33	24.50	1.040	0.261	/

Body												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas. SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
WCDMA Band 4 (RMC*)	Front	1513	1752.6	0.080	0.426	100.00	1.000	25.64	26.00	1.086	0.463	/
	Back	1513	1752.6	-3.730	0.480	100.00	1.000	25.64	26.00	1.086	**0.521**	2#
	Left	1513	1752.6	1.070	0.362	100.00	1.000	25.64	26.00	1.086	0.393	/
	Top	1513	1752.6	2.950	0.242	100.00	1.000	25.64	26.00	1.086	0.263	/
	Bottom	1513	1752.6	-2.290	0.233	100.00	1.000	25.64	26.00	1.086	0.253	/

Body												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas. SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
WCDMA Band 5 (RMC*)	Front	4182	836.4	-0.500	0.419	100.00	1.000	28.14	28.50	1.086	0.455	/
	Back	4182	836.4	3.970	0.515	100.00	1.000	28.14	28.50	1.086	**0.559**	3#
	Left	4182	836.4	0.520	0.374	100.00	1.000	28.14	28.50	1.086	0.406	/
	Top	4182	836.4	1.930	0.256	100.00	1.000	28.14	28.50	1.086	0.278	/
	Bottom	4182	836.4	-2.460	0.248	100.00	1.000	28.14	28.50	1.086	0.269	/

Body													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 2 (BW: 20MHz)	1RB	Front	19100	1900.0	2.890	0.551	100.00	1.000	23.39	23.50	1.026	0.565	/
		Back	19100	1900.0	-1.410	0.580	100.00	1.000	23.39	23.50	1.026	**0.595**	4#
		Left	19100	1900.0	-2.730	0.523	100.00	1.000	23.39	23.50	1.026	0.537	/
		Top	19100	1900.0	-3.170	0.362	100.00	1.000	23.39	23.50	1.026	0.371	/
		Bottom	19100	1900.0	-3.900	0.354	100.00	1.000	23.39	23.50	1.026	0.363	/
	50%RB	Front	19100	1900.0	-1.410	0.528	100.00	1.000	22.55	23.00	1.109	0.586	/
		Back	19100	1900.0	-2.160	0.557	100.00	1.000	22.55	23.00	1.109	0.618	/
		Left	19100	1900.0	-2.460	0.504	100.00	1.000	22.55	23.00	1.109	0.559	/
		Top	19100	1900.0	-1.780	0.335	100.00	1.000	22.55	23.00	1.109	0.372	/
		Bottom	19100	1900.0	-1.980	0.327	100.00	1.000	22.55	23.00	1.109	0.363	/

Body													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 4 (BW: 20MHz)	1RB	Front	20175	1732.5	2.520	0.618	100.00	1.000	23.55	24.00	1.109	0.685	/
		Back	20175	1732.5	-3.800	0.649	100.00	1.000	23.55	24.00	1.109	**0.720**	5#
		Left	20175	1732.5	4.310	0.587	100.00	1.000	23.55	24.00	1.109	0.651	/
		Top	20175	1732.5	-3.580	0.442	100.00	1.000	23.55	24.00	1.109	0.490	/
		Bottom	20175	1732.5	1.450	0.435	100.00	1.000	23.55	24.00	1.109	0.482	/
	50%RB	Front	20175	1732.5	-2.430	0.589	100.00	1.000	22.64	23.00	1.086	0.640	/
		Back	20175	1732.5	2.330	0.616	100.00	1.000	22.64	23.00	1.086	0.669	/
		Left	20175	1732.5	-3.890	0.559	100.00	1.000	22.64	23.00	1.086	0.607	/
		Top	20175	1732.5	-1.550	0.418	100.00	1.000	22.64	23.00	1.086	0.454	/
		Bottom	20175	1732.5	-1.510	0.410	100.00	1.000	22.64	23.00	1.086	0.445	/

Body

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 5 (BW: 10MHz)	1RB	Front	20450	829.0	2.150	0.673	100.00	1.000	23.60	24.00	1.096	0.738	/
		Back	20450	829.0	-2.380	0.728	100.00	1.000	23.60	24.00	1.096	**0.798**	6#
		Left	20450	829.0	-0.890	0.645	100.00	1.000	23.60	24.00	1.096	0.707	/
		Top	20450	829.0	-3.290	0.586	100.00	1.000	23.60	24.00	1.096	0.642	/
		Bottom	20450	829.0	2.070	0.580	100.00	1.000	23.60	24.00	1.096	0.636	/
	50%RB	Front	20450	829.0	-3.450	0.646	100.00	1.000	23.63	24.00	1.089	0.703	/
		Back	20450	829.0	-1.500	0.706	100.00	1.000	23.63	24.00	1.089	0.769	/
		Left	20450	829.0	-3.320	0.622	100.00	1.000	23.63	24.00	1.089	0.677	/
		Top	20450	829.0	-1.320	0.564	100.00	1.000	23.63	24.00	1.089	0.614	/
		Bottom	20450	829.0	-1.040	0.555	100.00	1.000	23.63	24.00	1.089	0.604	/

Body													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 7 (BW: 20MHz)	1RB	Front	21100	2535.0	1.780	0.668	100.00	1.000	23.07	23.50	1.104	0.737	/
		Back	21100	2535.0	-1.930	0.713	100.00	1.000	23.07	23.50	1.104	**0.787**	7#
		Left	21100	2535.0	-1.470	0.635	100.00	1.000	23.07	23.50	1.104	0.701	/
		Top	21100	2535.0	-3.700	0.574	100.00	1.000	23.07	23.50	1.104	0.634	/
		Bottom	21100	2535.0	1.520	0.564	100.00	1.000	23.07	23.50	1.104	0.623	/
	50%RB	Front	21100	2535.0	-4.470	0.646	100.00	1.000	22.20	22.50	1.072	0.693	/
		Back	21100	2535.0	-1.670	0.685	100.00	1.000	22.20	22.50	1.072	0.734	/
		Left	21100	2535.0	-3.750	0.612	100.00	1.000	22.20	22.50	1.072	0.656	/
		Top	21100	2535.0	-1.090	0.551	100.00	1.000	22.20	22.50	1.072	0.591	/
		Bottom	21100	2535.0	-0.570	0.542	100.00	1.000	22.20	22.50	1.072	0.581	/

Body													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 38 (BW: 20MHz)	1RB	Front	38150	2610.0	1.410	0.381	100.00	1.000	23.04	23.50	1.112	0.424	/
		Back	38150	2610.0	1.970	0.416	100.00	1.000	23.04	23.50	1.112	**0.463**	8#
		Left	38150	2610.0	-2.050	0.352	100.00	1.000	23.04	23.50	1.112	0.391	/
		Top	38150	2610.0	-4.110	0.228	100.00	1.000	23.04	23.50	1.112	0.254	/
		Bottom	38150	2610.0	0.970	0.221	100.00	1.000	23.04	23.50	1.112	0.246	/
	50%RB	Front	38150	2610.0	-2.490	0.3358	100.00	1.000	22.13	22.50	1.089	0.366	/
		Back	38150	2610.0	-1.840	0.393	100.00	1.000	22.13	22.50	1.089	0.428	/
		Left	38150	2610.0	-4.180	0.330	100.00	1.000	22.13	22.50	1.089	0.359	/
		Top	38150	2610.0	-0.860	0.203	100.00	1.000	22.13	22.50	1.089	0.221	/
		Bottom	38150	2610.0	-0.100	0.195	100.00	1.000	22.13	22.50	1.089	0.212	/

Body													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 41 (BW: 20MHz)	1RB	Front	41140	2645.0	1.040	0.392	100.00	1.000	23.44	23.50	1.014	0.397	/
		Back	41140	2645.0	-3.420	0.433	100.00	1.000	23.44	23.50	1.014	**0.439**	9#
		Left	41140	2645.0	-2.630	0.361	100.00	1.000	23.44	23.50	1.014	0.366	/
		Top	41140	2645.0	-3.520	0.245	100.00	1.000	23.44	23.50	1.014	0.248	/
		Bottom	41140	2645.0	1.420	0.236	100.00	1.000	23.44	23.50	1.014	0.239	/
	50%RB	Front	41140	2645.0	-3.510	0.375	100.00	1.000	22.33	22.50	1.040	0.390	/
		Back	41140	2645.0	-2.010	0.411	100.00	1.000	22.33	22.50	1.040	0.427	/
		Left	41140	2645.0	-4.210	0.343	100.00	1.000	22.33	22.50	1.040	0.357	/
		Top	41140	2645.0	-1.630	0.320	100.00	1.000	22.33	22.50	1.040	0.333	/
		Bottom	41140	2645.0	0.370	0.312	100.00	1.000	22.33	22.50	1.040	0.324	/

Body											
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

2.4g (2.4~2.4835) 802.11b-Ant.1	Front	1	2412	1.360	0.455	100.00	1.000	16.78	17.00	1.052	0.479	/
	Back	1	2412	-2.920	0.490	100.00	1.000	16.78	17.00	1.052	**0.515**	10#
	Left	1	2412	-2.540	0.343	100.00	1.000	16.78	17.00	1.052	0.361	/
	Right	1	2412	-0.170	0.337	100.00	1.000	16.78	17.00	1.052	0.355	/
	Bottom	1	2412	3.320	0.413	100.00	1.000	16.78	17.00	1.052	0.434	/
2.4g (2.4~2.4835) 802.11b-Ant.2	Front	1	2412	-4.070	0.436	100.00	1.000	16.43	16.50	1.016	0.443	/
	Back	1	2412	-0.240	0.472	100.00	1.000	16.43	16.50	1.016	0.480	/
	Left	1	2412	-1.060	0.332	100.00	1.000	16.43	16.50	1.016	0.337	/
	Right	1	2412	0.990	0.326	100.00	1.000	16.43	16.50	1.016	0.331	/
	Top	1	2412	3.210	0.402	100.00	1.000	16.43	16.50	1.016	0.408	/
2.4g (2.4~2.4835) 802.11n(HT20)-MIMO	Front	1	2412	-3.120	0.405	100.00	1.000	13.93	14.00	1.016	0.411	/
	Back	1	2412	-0.880	0.435	100.00	1.000	13.93	14.00	1.016	0.442	/
	Left	1	2412	2.770	0.256	100.00	1.000	13.93	14.00	1.016	0.260	/
	Right	1	2412	1.370	0.247	100.00	1.000	13.93	14.00	1.016	0.251	
	Top	1	2412	3.090	0.339	100.00	1.000	13.93	14.00	1.016	0.344	/
	Bottom	1	2412	-0.410	0.330	100.00	1.000	13.93	14.00	1.016	0.335	/

Note:
1. Per KDB 447498 D04 v01, for each exposure position, if the highest output power channel Reported SAR ≤ 0.8W/kg, other channels SAR testing is not necessary.
2. Per KDB 447498 D04 v01, body use is evaluated with the device positioned at 0mm from a flat phantom respectively filled with body tissue-equivalent medium.
3. Per KDB 616217 D04 where SAR test considerations for tablets are based on a composite test separation distance of 0 mm from the back and edges of the device with antennas 2.5 cm or closer to the edge of the device, determined from general mixed use conditions for this type of devices.
4. Per KDB 447498 D04 v01, the report SAR is measured SAR value adjusted for maximum tune-up tolerance. Scaling Factor=10^[(tune-up limit power(dBm) - Ave.power power (dBm))/10], where tune-up limit is the maximum rated power among all production units.
   Reported SAR(W/kg)=Measured SAR (W/kg)*Scaling Factor.

11. SAR Measurement Variability

According to KDB 865664 D01, SAR measurement variability was assessed for each frequency band, which is determined by the SAR probe calibration point and tissue-equivalent medium used for the device measurements. When both head and body tissue-equivalent media are required for SAR measurements in a frequency band, the variability measurement procedures should be applied to the tissue medium with the highest measured SAR, using the highest measured SAR configuration for that tissue-equivalent medium. Alternatively, if the highest measured SAR for both head and body tissue-equivalent media are ≤ 1.45 W/kg and the ratio of these highest SAR values, i.e., largest divided by smallest value, is ≤ 1.10, the highest SAR configuration for either head or body tissue-equivalent medium may be used to perform the repeated measurement. These additional measurements are repeated after the completion of all measurements requiring the same head or body tissue-equivalent medium in a frequency band. The test device should be returned to ambient conditions (normal room temperature) with the battery fully charged before it is re-mounted on the device holder for the repeated measurement(s) to minimize any unexpected variations in the repeated results.

SAR repeated measurement procedure:

1. When the highest measured SAR is < 0.80 W/kg, repeated measurement is not required.
2. When the highest measured SAR is >= 0.80 W/kg, repeat that measurement once.
3. If the ratio of largest to smallest SAR for the original and first repeated measurements is > 1.20, or when the original or repeated measurement is >= 1.45 W/kg, perform a second repeated measurement.
4. If the ratio of largest to smallest SAR for the original, first and second repeated measurements is > 1.20, and the original, first or second repeated measurement is >= 1.5 W/kg, perform a third repeated measurement.

Note: For 1g SAR, the highest measured 1g SAR is 0.723 < 0.80 W/kg, repeated measurement is not required.

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

12. Simultaneous Transmission

Simultaneous transmission SAR test exclusion is determined for each operating configuration and exposure condition according to the reported standalone SAR of each applicable simultaneous transmitting antenna. When the sum of SAR 1g of all simultaneously transmitting antennas in an operating mode and exposure condition combination is within the SAR limit (SAR 1g 1.6 W/kg), the simultaneous transmission SAR is not required. When the sum of SAR 1g is greater than the SAR limit (SAR 1g 1.6 W/kg), SAR test exclusion is determined by the SAR to Peak Location Ratio (SPLSR).

12.1 Simultaneous Transmission Mode Considerations

Simultaneous transmission SAR test exclusion is determined for each operating configuration and exposure condition according to the reported standalone SAR of each applicable simultaneous transmitting antenna. The device has 3 Tx antennas, WWAN main antenna, Wifi antenna supports 2.4G Wi-Fi. The 2 antennas can always transmit simultaneously. The work mode combination is showed as below table.

Application Simultaneous Transmission information:

NO.	Configuration	Body
1	WWAN+WIFI(2.4g)	Yes

12.2 Sum SAR of Simultaneous Transmission

Body

Band	Test Position	Channel Type	Scaled SAR		Σ SAR (W/kg)` WWAN + WIFI 2.4G	SPLSR	Remark
			WWAN	2.4G WIFI			
GPRS 1900+4slots	Front	1RB	0.738	0.479	1.217	N/A	N/A
	Back		**0.798**	**0.515**	**1.313**	N/A	N/A
	Left		0.707	0.361	1.068	N/A	N/A
	Right		/	0.355	0.355	N/A	N/A
	Top		0.642	/	0.642	N/A	N/A
	Bottom		0.636	0.434	1.070	N/A	N/A
	Front	50%RB	0.703	0.479	1.182	N/A	N/A
	Back		0.769	0.515	1.284	N/A	N/A
	Left		0.677	0.361	1.038	N/A	N/A
	Right		/	0.355	0.355	N/A	N/A
	Top		0.614	/	0.614	N/A	N/A
	Bottom		0.604	0.434	1.038	N/A	N/A

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

13. Test Equipment List

Description	Manufacturer	Model	Serial No./Version	Cal. Date	Cal. Due
E-Field Probe	MVG	SSE2	04/22 EPGO365	2024/02/06	2025/02/05
6 1/2 Digital Multimeter	Keithley	DMM6500	4527164	2023/11/16	2024/11/15
Wideband Radio Communication Tester	ROHDE & SCHWARZ	CMW500	161997	2023/11/16	2024/11/15
MXG Vector Signal Generator	Agilent	N5182A	MY46240163	2023/11/16	2024/11/15
E-Series Avg. Power Sensor	KEYSIGHT	E9300A	MY55050017	2024/03/20	2025/03/19
EPM Series Power Meter	KEYSIGHT	E4418B	MY41293435	2024/03/20	2025/03/19
10dB Attenuator	MIDWEST MICROWAVE	263-10dB	/	2024/03/20	2025/03/19
Coupler	MERRIMAC	CWM-10R-10.8G	LOT-83391	2024/03/20	2025/03/19
835MHz Validation Dipole	MVG	SID835	07/22 DIP 0G835-656	2023/02/06	2025/02/05
1800MHz Validation Dipole	MVG	SID1800	07/22 DIP 1G800-657	2023/02/06	2025/02/05
1900MHz Validation Dipole	MVG	SID1900	07/22 DIP 1G900-658	2023/02/06	2025/02/05
2300MHz Validation Dipole	MVG	SID2300	07/22 DIP 2G300-661	2023/02/06	2025/02/05
2450MHz Validation Dipole	MVG	SID2450	07/22 DIP 2G450-662	2023/02/06	2025/02/05
2600MHz Validation Dipole	MVG	SID2600	07/22 DIP 2G600-663	2023/02/06	2025/02/05
LIMESAR Dielectric Probe	MVG	SCLMP	06/22 OCPG88	/	/
ENA Series Network Analyzer	Agilent	E5071B	MY42301221	2023/11/16	2024/11/15
Thermometer	Riters	DT-232	21A11	2024/03/20	2025/03/19
Antenna network emulator	MVG	ANTA 74	07/22 ANTA 74	/	/
SAM Phantom	MVG	SAM	07/22 SAM149	/	/
Mobile Phone Positioning System	MVG	MSH 118	07/22 MSH 118	/	/
Mechanical Calibration Kit	PNA	/	/	/	/
Open SAR test software	MVG	/	V5.3.5	/	/

Note: For dipole antennas, BTF has adopted 3 years as calibration intervals, and on annual basis, every measurement dipole has been evaluated and is in compliance with the following criteria:

1. There is no physical damage on the dipole;
2. System validation with specific dipole is within 10% of calibrated value;
3. Return-loss in within 20% of calibrated measurement.
4. Impedance (real or imaginary parts) in within 5 Ohms of calibrated measurement.

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

ANNEX A Simulating Liquid Verification Result

The dielectric parameters of the liquids were verified prior to the SAR evaluation using an SCLMP Dielectric Probe Kit.

Dielectric performance of tissue simulating liquid									
Frequency (MHz)	εr		σ(s/m)		Delta (εr)	Delta (σ)	Limit	Temp (℃)	Date
	Target	Measured	Target	Measured					
835	41.50	41.41	0.90	0.87	0.22%	3.33%	±5%	20.0	5/6/2024
1800	40.00	39.91	1.40	1.37	0.23%	2.14%	±5%	20.0	5/6/2024
1900	40.00	39.88	1.40	1.41	0.30%	-0.71%	±5%	20.0	6/6/2024
2300	39.50	39.30	1.67	1.70	-0.51%	1.85%	±5%	20.0	7/6/2024
2450	39.20	39.08	1.80	1.81	-0.31%	0.56%	±5%	20.0	11/6/2024
2600	39.00	38.88	1.96	1.97	-0.31%	0.51%	±5%	20.0	12/6/2024
NOTE: The dielectric parameters of the tissue-equivalent liquid should be measured under similar ambient conditions and within 2 ℃ of the conditions expected during the SAR evaluation to satisfy protocol requirements.									

ANNEX B System Check Result

Comparing to the original SAR value provided by MVG, the validation data should be within its specification of 10 %(for 10 g).

Frequency (MHz)	Input Power (mW)	10g SAR (W/Kg)	1g SAR (W/Kg)	10g SAR 1W input power normalized (W/Kg)	1g SAR 1W input power normalized (W/Kg)	10g SAR Standard target (1W) (W/Kg)	1g SAR Standard target (1W) (W/Kg)	10g SAR Deviation	1g SAR Deviation
835	16	0.106	0.163	6.63	10.19	6.17	9.79	7.37%	4.06%
1800	16	0.312	0.588	19.50	36.75	20.61	39.33	-5.39%	-6.56%
1900	16	0.322	0.630	20.13	39.38	20.70	40.97	-2.78%	-3.89%
2300	16	0.749	0.34	46.81	21.25	50.35	22.84	-7.03%	-6.96%
2450	16	0.352	0.793	22.00	49.56	23.86	54.40	-7.80%	-8.89%
2600	16	0.421	0.866	26.31	54.13	24.48	57.14	7.49%	-5.28%

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

System Performance Check Data (835 MHz)

System check at 835 MHz

Date of measurement: 5/6/2024

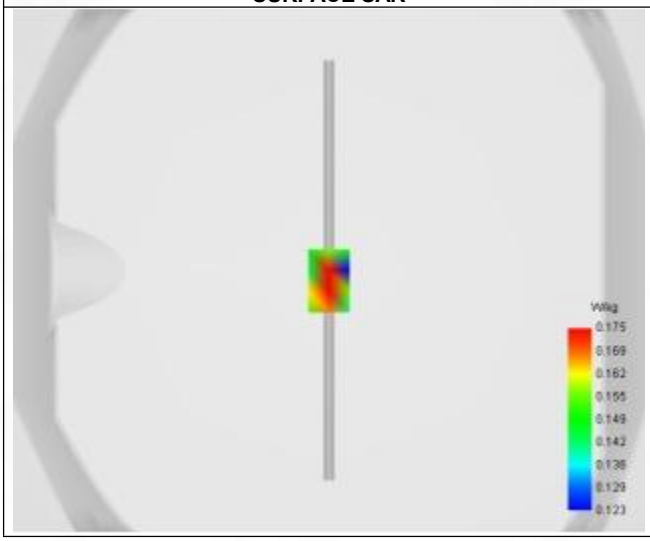
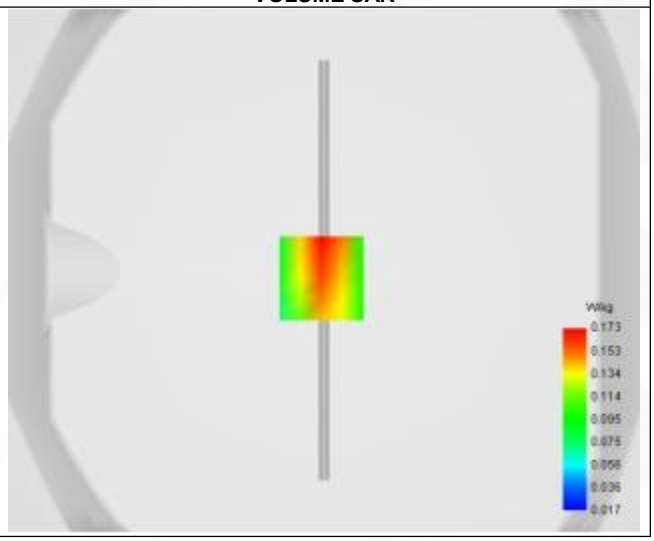
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.68
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW835
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	835.000
Relative permitivity (real part)	41.410
Relative permitivity (imaginary part)	19.490
Conductivity (S/m)	0.870

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-1.00, Y=-3.00 ; SAR Peak: 0.26 W/kg

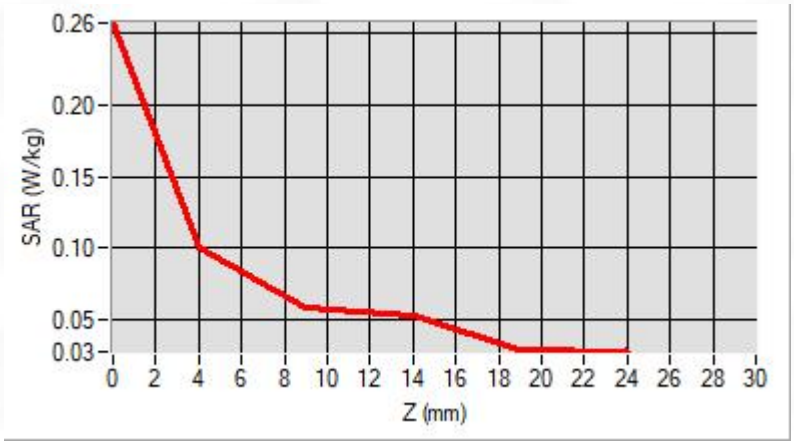
D. SAR 1g & 10g

SAR 10g (W/Kg)	0.106
SAR 1g (W/Kg)	0.163
Variation (%)	-3.390
Horizontal validation criteria: minimum distance (mm)	8.487
Vertical validation criteria: SAR ratio M2/M1 (%)	66.47%

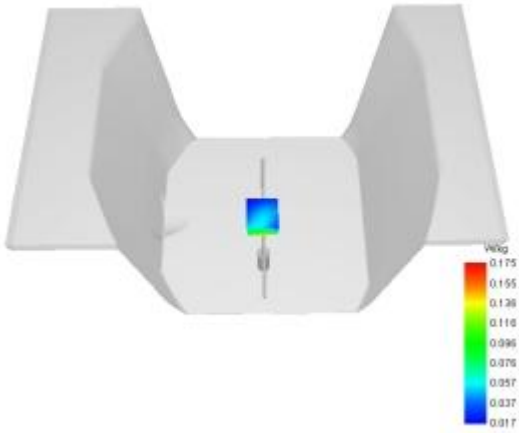
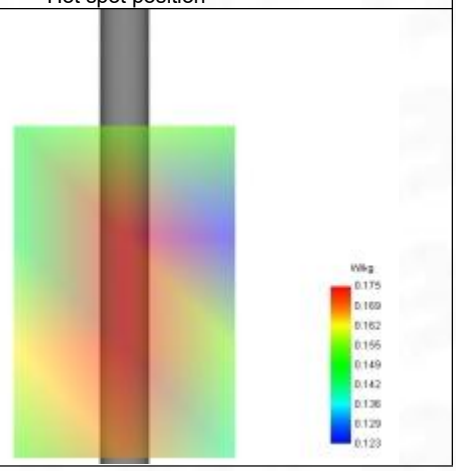
E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.059	0.173	0.115	0.061	0.072

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China



F. 3D Image

3D screen shot	Hot spot position
	

System Performance Check Data (1800 MHz)

System check at 1800 MHz

Date of measurement: 5/6/2024

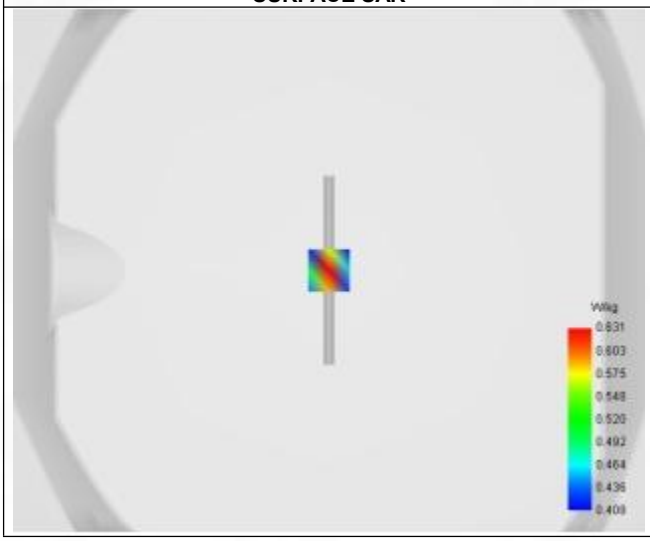
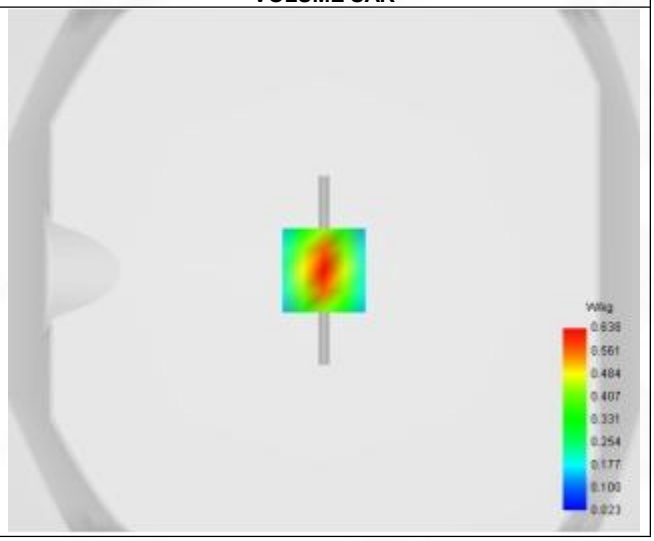
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.96
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW1800
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	1800.000
Relative permitivity (real part)	39.910
Relative permitivity (imaginary part)	14.090
Conductivity (S/m)	1.370

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=0.00 ; SAR Peak: 1.00 W/kg

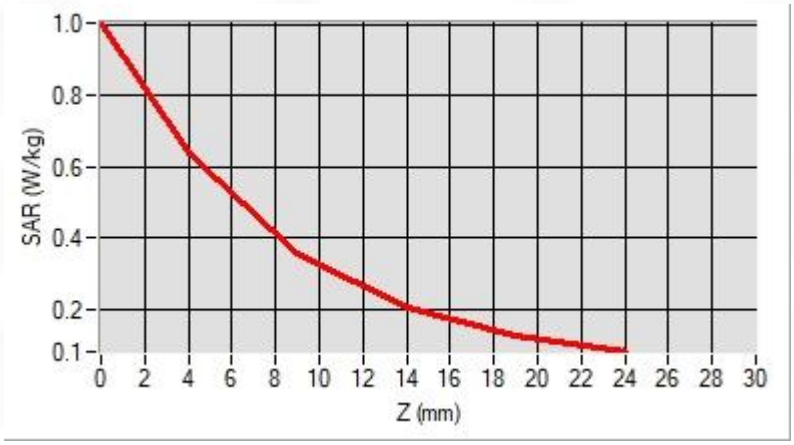
D. SAR 1g & 10g

SAR 10g (W/Kg)	0.312
SAR 1g (W/Kg)	0.588
Variation (%)	-0.250
Horizontal validation criteria: minimum distance (mm)	8.698
Vertical validation criteria: SAR ratio M2/M1 (%)	55.80%

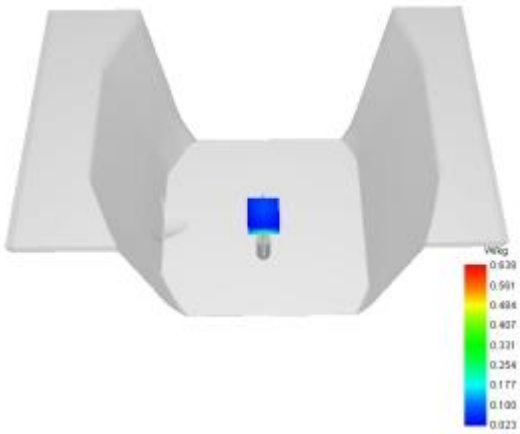
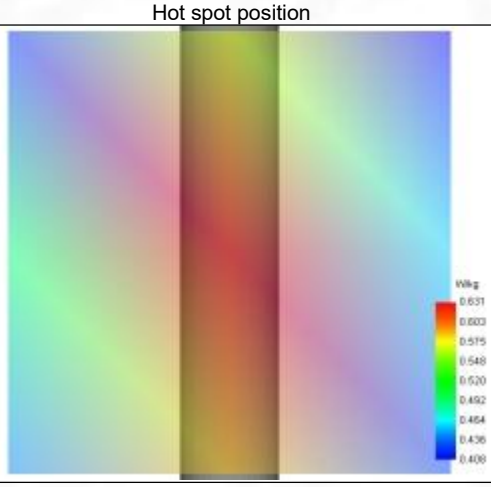
E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.003	0.638	0.356	0.204	0.127

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China



F. 3D Image

3D screen shot	Hot spot position
	

System Performance Check Data (1900 MHz)

System check at 1900 MHz

Date of measurement: 6/6/2024

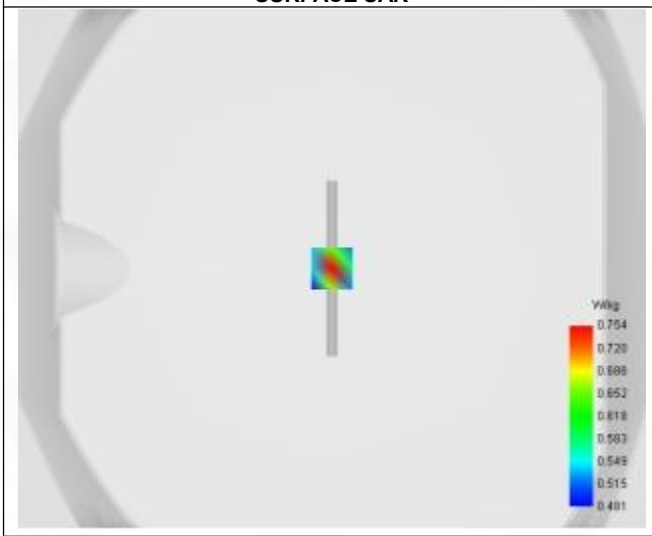
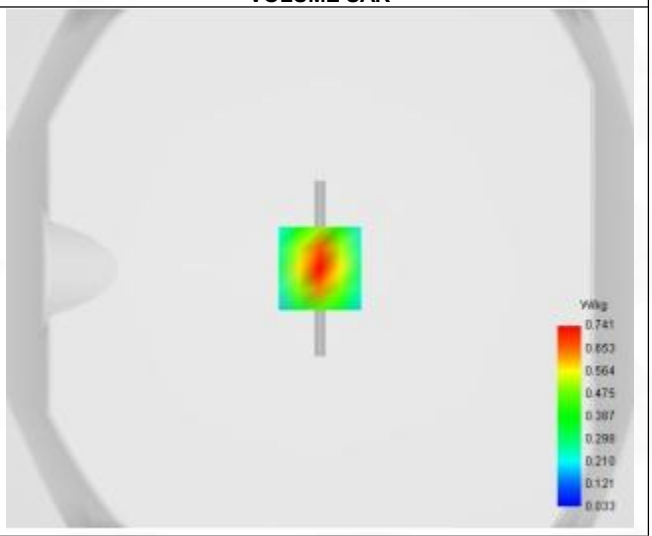
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.24
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW1900
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	1900.000
Relative permitivity (real part)	39.880
Relative permitivity (imaginary part)	13.380
Conductivity (S/m)	1.410

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=0.00 ; SAR Peak: 1.18 W/kg

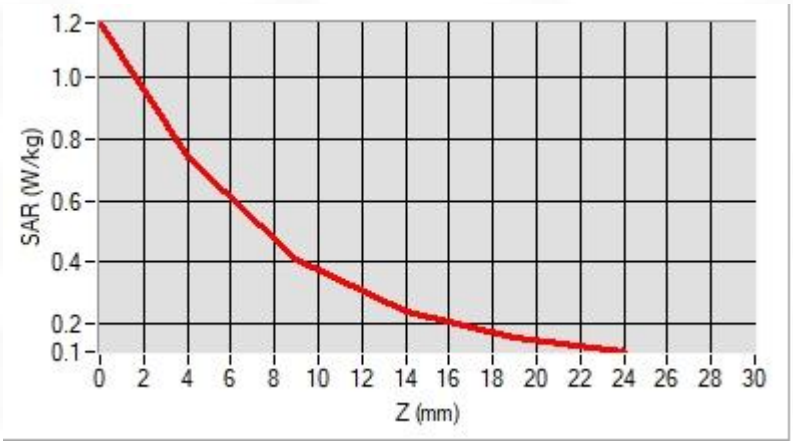
D. SAR 1g & 10g

SAR 10g (W/Kg)	0.322
SAR 1g (W/Kg)	0.630
Variation (%)	-2.080
Horizontal validation criteria: minimum distance (mm)	8.699
Vertical validation criteria: SAR ratio M2/M1 (%)	52.96%

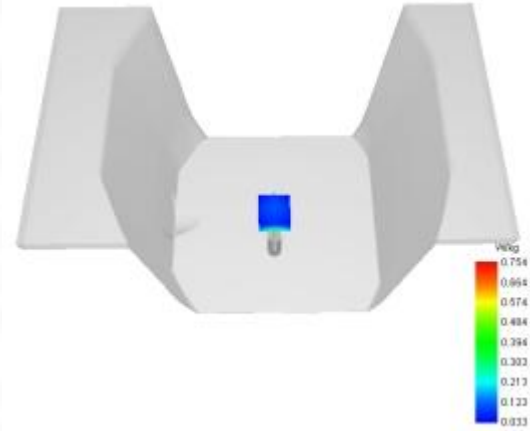
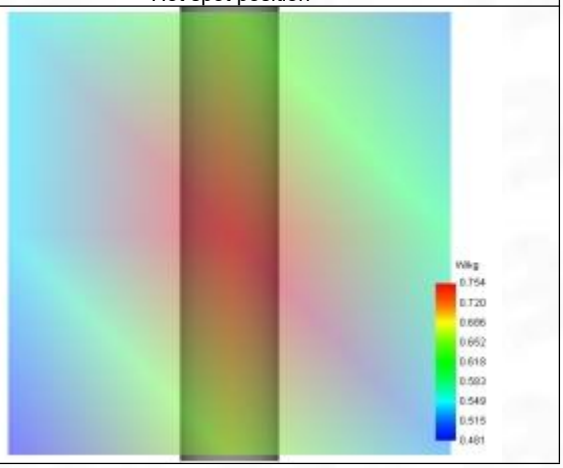
E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.201	0.759	0.402	0.239	0.156

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China



F. 3D Image

3D screen shot	Hot spot position
	

System Performance Check Data (2300 MHz)

System check at 2300 MHz

Date of measurement: 7/6/2024

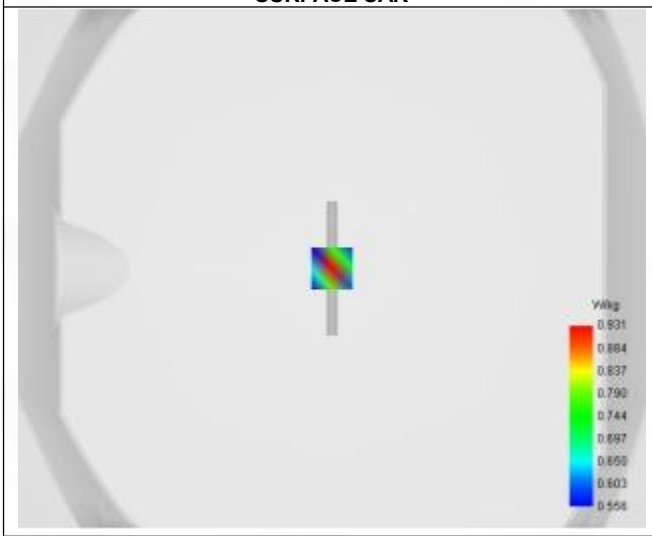
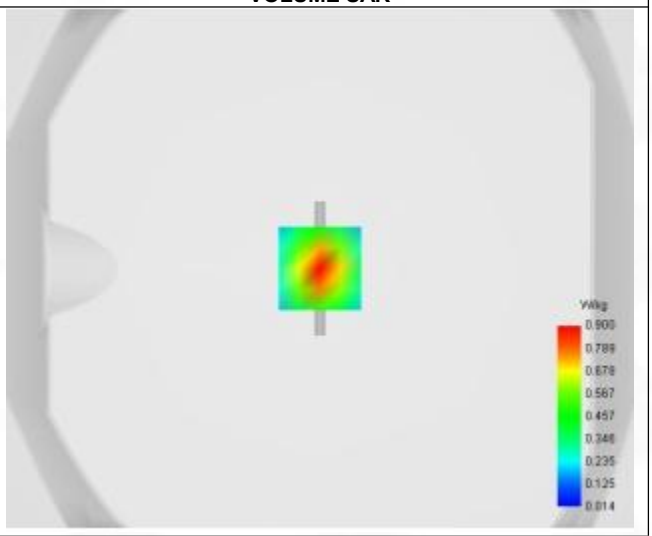
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.36
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW2300
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	2300.000
Relative permitivity (real part)	39.298
Relative permitivity (imaginary part)	13.351
Conductivity (S/m)	1.701

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=0.00 ; SAR Peak: 1.40 W/kg

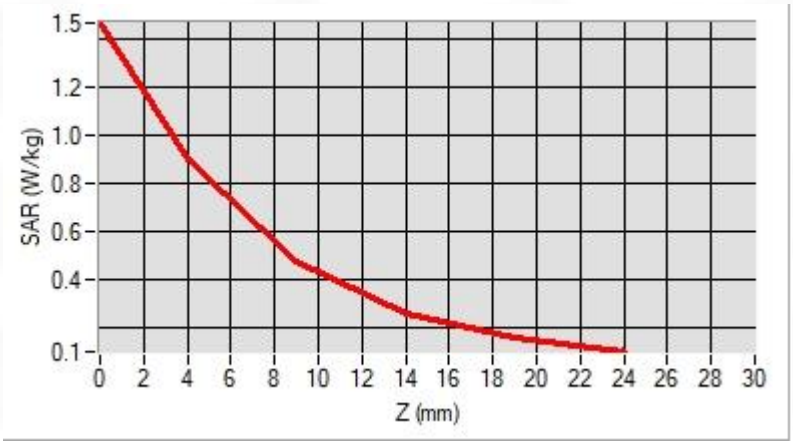
D. SAR 1g & 10g

SAR 10g (W/Kg)	0.340
SAR 1g (W/Kg)	0.749
Variation (%)	-2.880
Horizontal validation criteria: minimum distance (mm)	8.474
Vertical validation criteria: SAR ratio M2/M1 (%)	53.00%

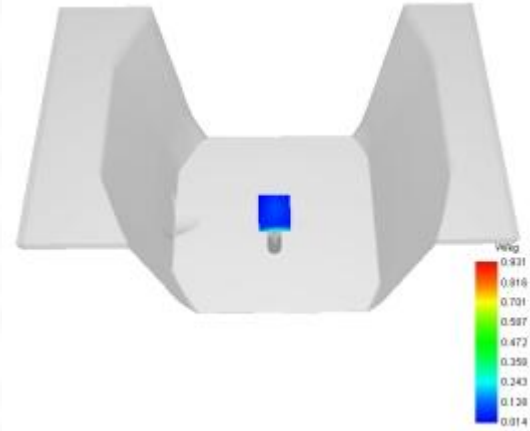
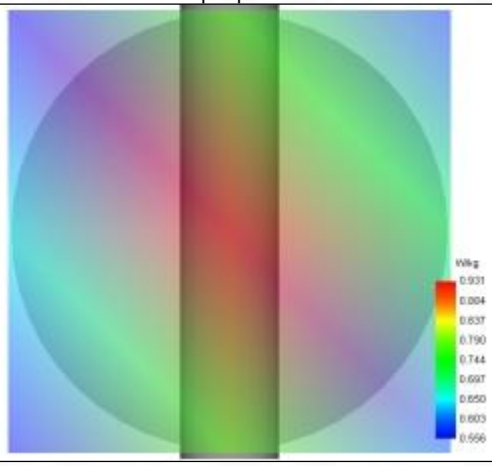
E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.400	0.900	0.477	0.261	0.150

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China



F. 3D Image

3D screen shot	Hot spot position
	

System Performance Check Data (2450 MHz)

System check at 2450 MHz

Date of measurement: 11/6/2024

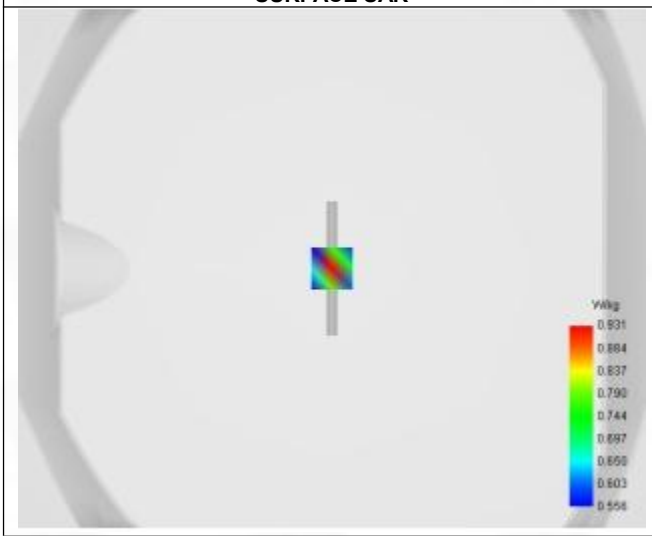
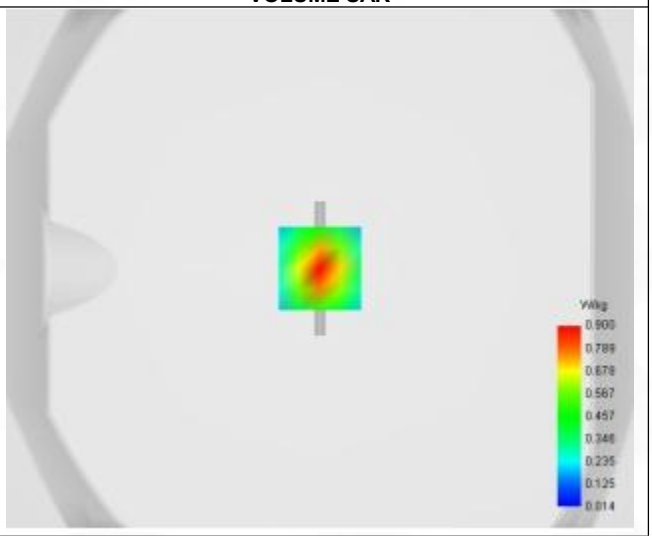
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.36
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=5mm dy=5mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW2450
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	2450.000
Relative permitivity (real part)	39.080
Relative permitivity (imaginary part)	13.340
Conductivity (S/m)	1.810

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=0.00 ; SAR Peak: 1.47 W/kg

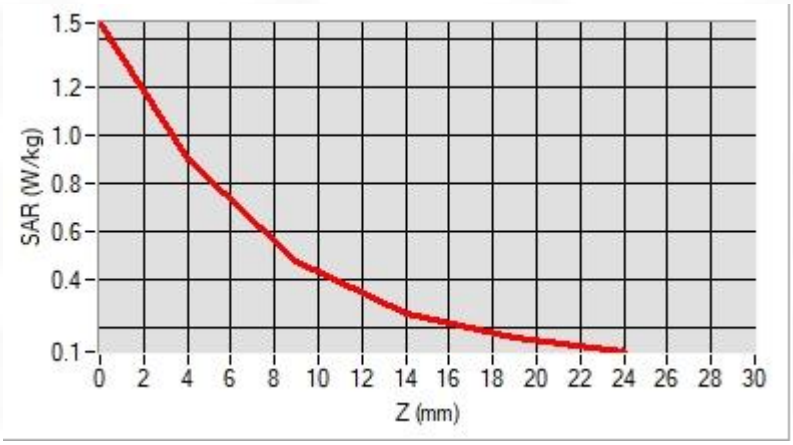
D. SAR 1g & 10g

SAR 10g (W/Kg)	0.352
SAR 1g (W/Kg)	0.793
Variation (%)	-2.570
Horizontal validation criteria: minimum distance (mm)	9.787
Vertical validation criteria: SAR ratio M2/M1 (%)	53.00%

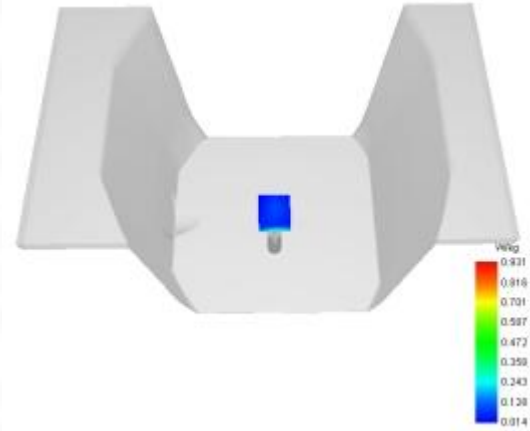
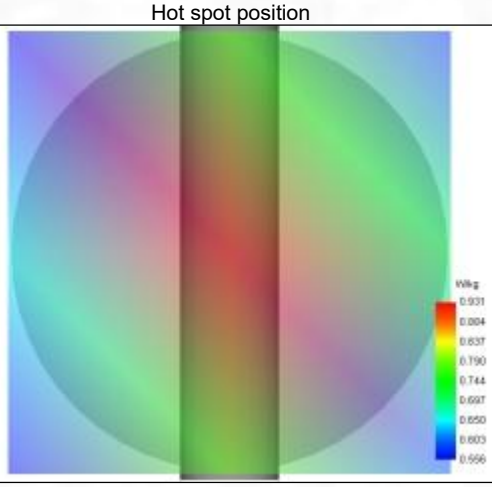
E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.466	0.900	0.477	0.261	0.158

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China



F. 3D Image

3D screen shot	Hot spot position
	

System Performance Check Data (2600 MHz)

System check at 2600 MHz

Date of measurement: 12/6/2024

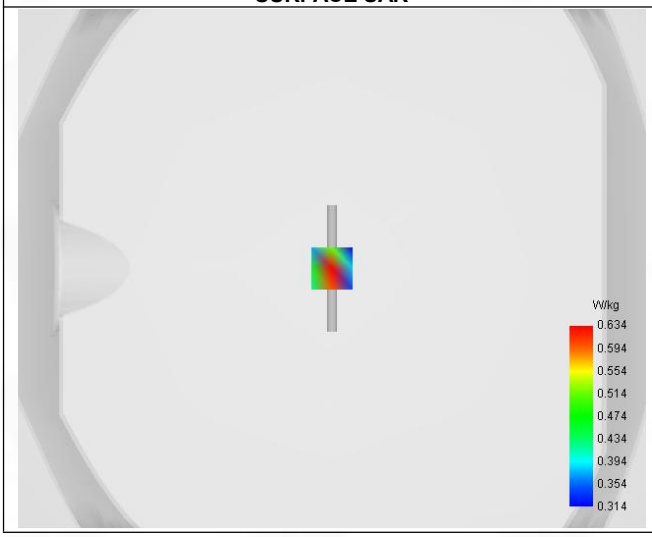
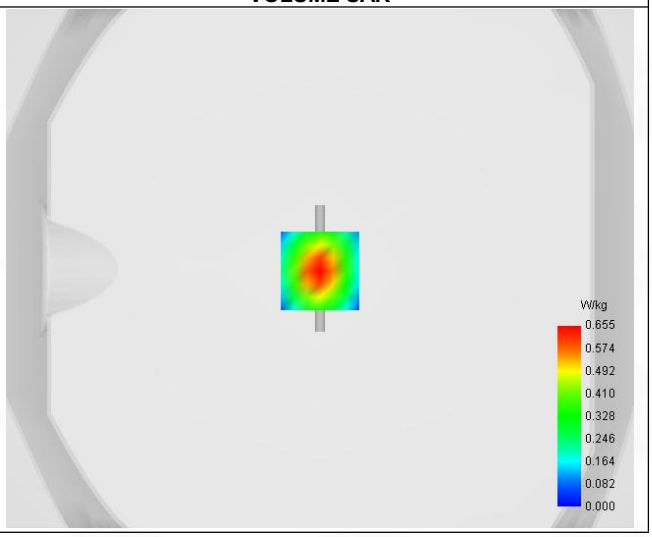
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.40
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW2600
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	2600.000
Relative permitivity (real part)	38.880
Relative permitivity (imaginary part)	12.690
Conductivity (S/m)	1.970

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=-1.00 ; SAR Peak: 1.02 W/kg

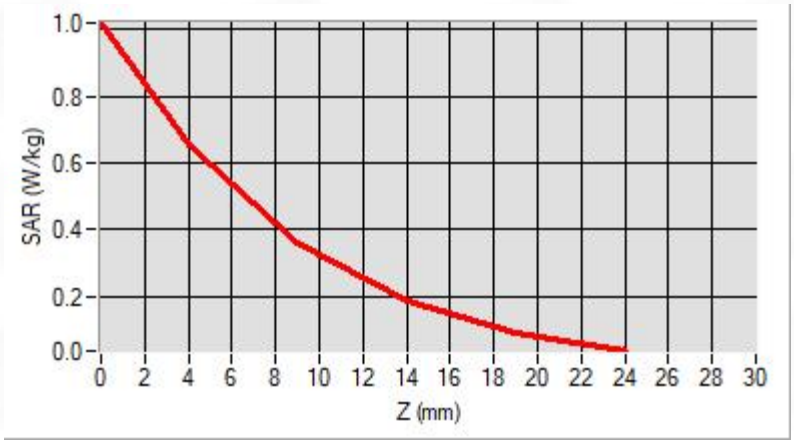
D. SAR 1g & 10g

SAR 10g (W/Kg)	0.421
SAR 1g (W/Kg)	0.866
Variation (%)	2.980
Horizontal validation criteria: minimum distance (mm)	8.298
Vertical validation criteria: SAR ratio M2/M1 (%)	54.81%

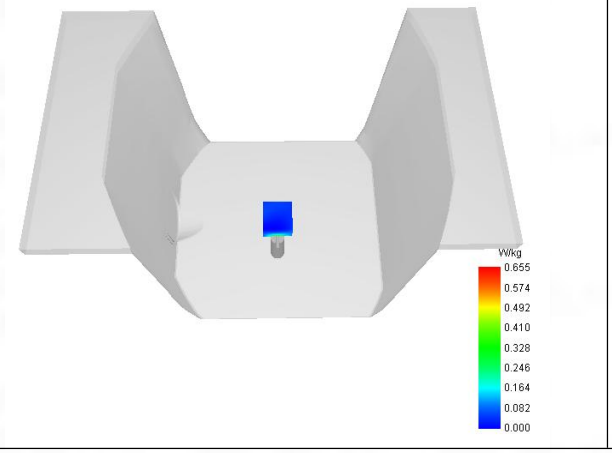
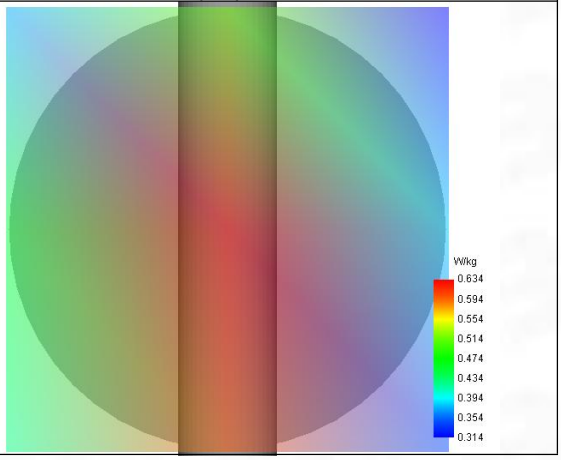
E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.020	0.655	0.359	0.187	0.091

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China



F. 3D Image

3D screen shot	Hot spot position
	

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

ANNEX C Test Data

1-Body with back position in dist. 0mm on Channel 9538 in WCDMA Band II

SAR Measurement at Band 2 (1900) (Body, Validation Plane)

Date of measurement: 6/6/2024

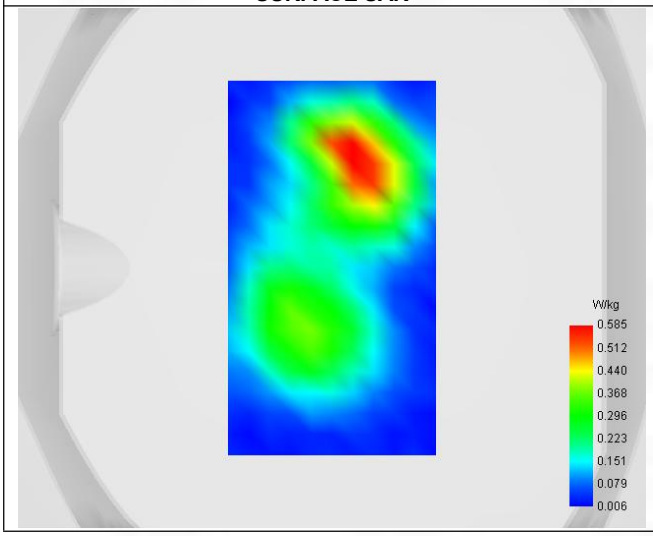
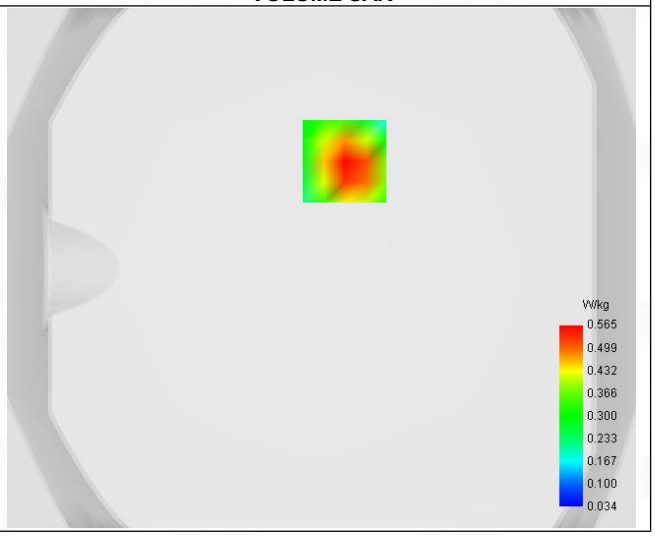
A. Experimental conditions.

Probe	SN 04/22 EPGO366
ConvF	2.07
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	Band 2 (1900)
Channels	Higher (9538)
Signal	WCDMA
Mode	Release 99
Connection Type	RMC, 12.2 kbps

B. Permitivity

Frequency (MHz)	1907.600
Relative permitivity (real part)	39.869
Relative permitivity (imaginary part)	13.379
Conductivity (S/m)	1.416

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=9.00, Y=41.00 ; SAR Peak: 0.82 W/kg

D. SAR 1g & 10g

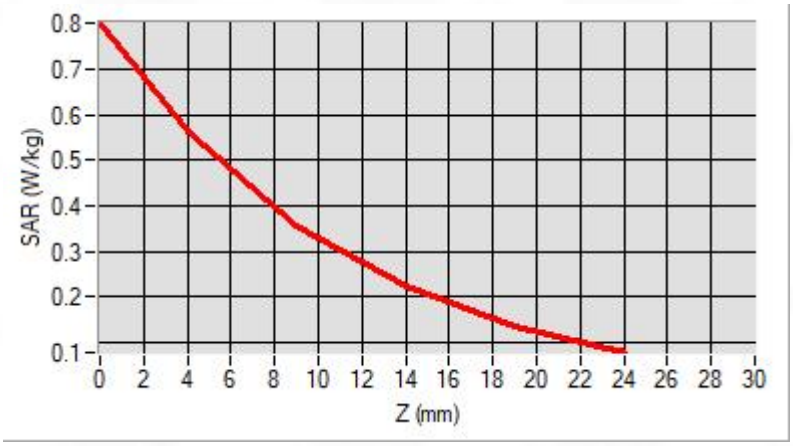
SAR 10g (W/Kg)	0.314
SAR 1g (W/Kg)	0.540
Variation (%)	-2.780
Horizontal validation criteria: minimum distance (mm)	8.798
Vertical validation criteria: SAR ratio M2/M1 (%)	63.19%

E. Z Axis Scan

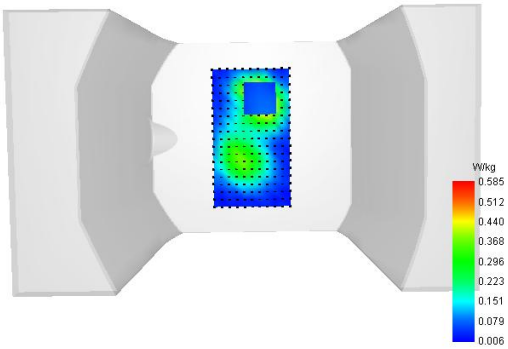
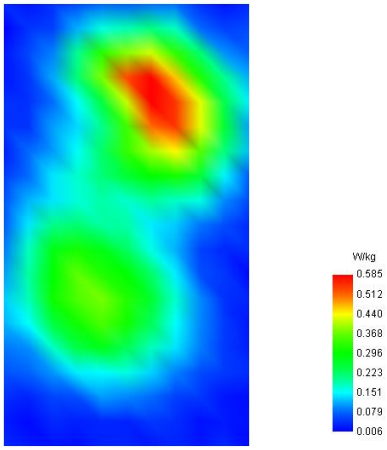
Z (mm)	0.00	4.00	9.00	14.00	19.00

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

SAR (W/Kg)	0.802	0.565	0.357	0.222	0.136



F. 3D Image

3D screen shot	Hot spot position
	

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

2-Body with back position in dist. 0mm on Channel 1513 in WCDMA Band IV

SAR Measurement at Band 4 (1700) (Body, Validation Plane)

Date of measurement: 5/6/2024

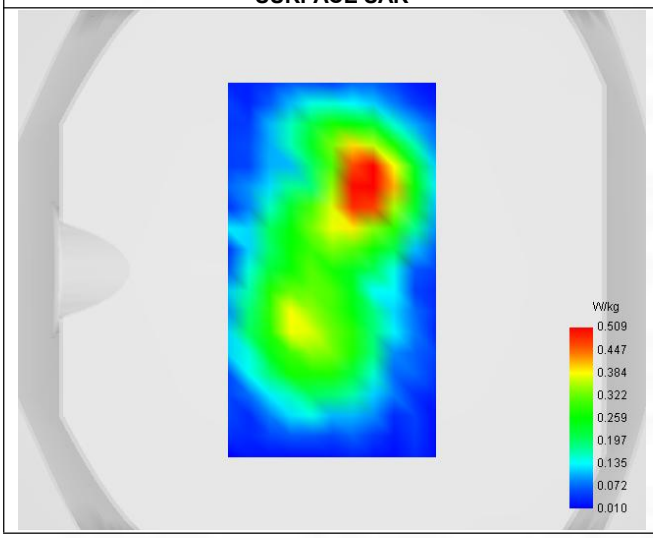
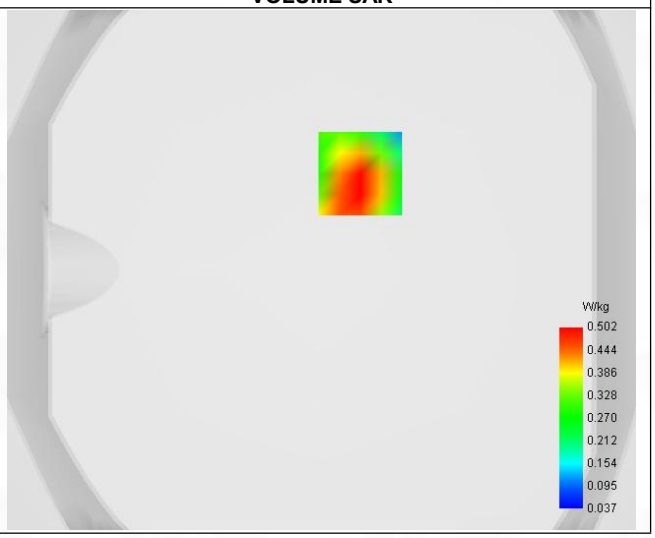
A. Experimental conditions.

Probe	SN 04/22 EPGO366
ConvF	1.79
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	Band 4 (1700)
Channels	Higher (1513)
Signal	WCDMA
Mode	Release 99
Connection Type	RMC, 12.2 kbps

B. Permitivity

Frequency (MHz)	1752.600
Relative permitivity (real part)	39.984
Relative permitivity (imaginary part)	14.355
Conductivity (S/m)	1.345

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=15.00, Y=37.00 ; SAR Peak: 0.72 W/kg

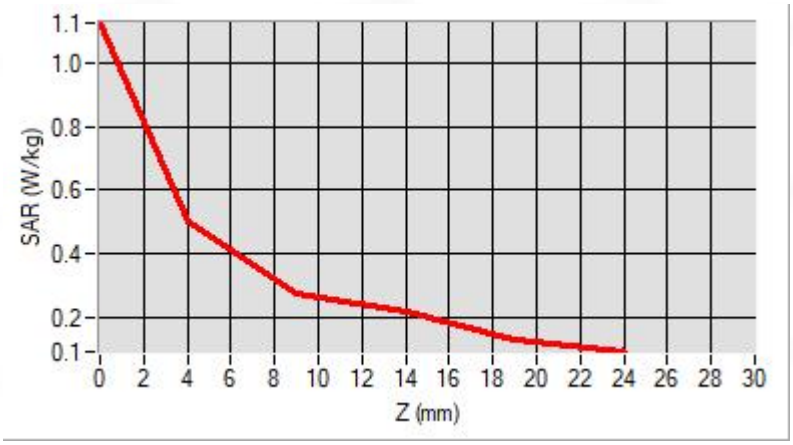
D. SAR 1g & 10g

SAR 10g (W/Kg)	0.294
SAR 1g (W/Kg)	0.480
Variation (%)	-3.730
Horizontal validation criteria: minimum distance (mm)	9.625
Vertical validation criteria: SAR ratio M2/M1 (%)	54.38%

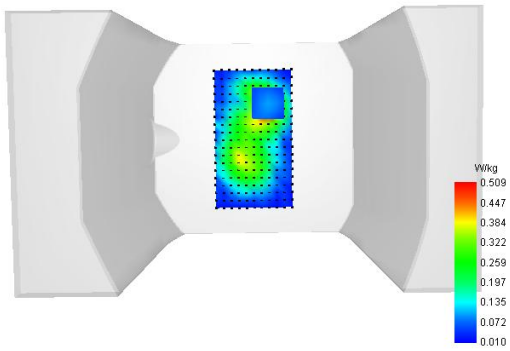
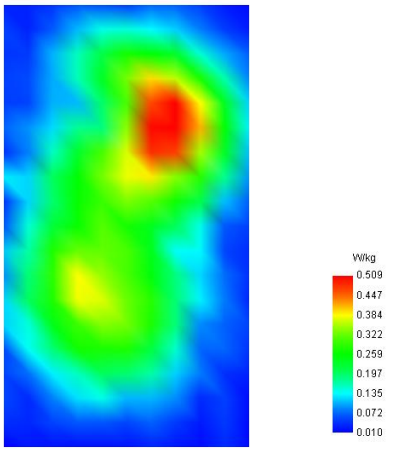
E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.128	0.502	0.273	0.215	0.126

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China



F. 3D Image

3D screen shot	Hot spot position
	

3-Body with back position in dist. 0mm on Channel 4182 in WCDMA Band V

SAR Measurement at Band 5 (850) (Body, Validation Plane)

Date of measurement: 5/6/2024

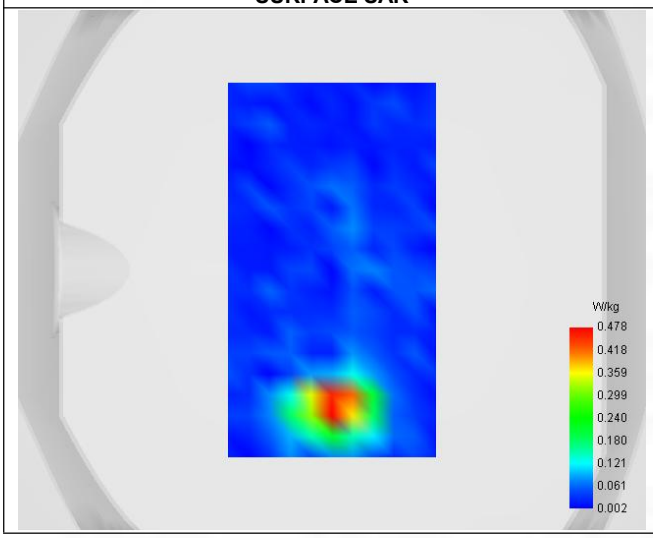
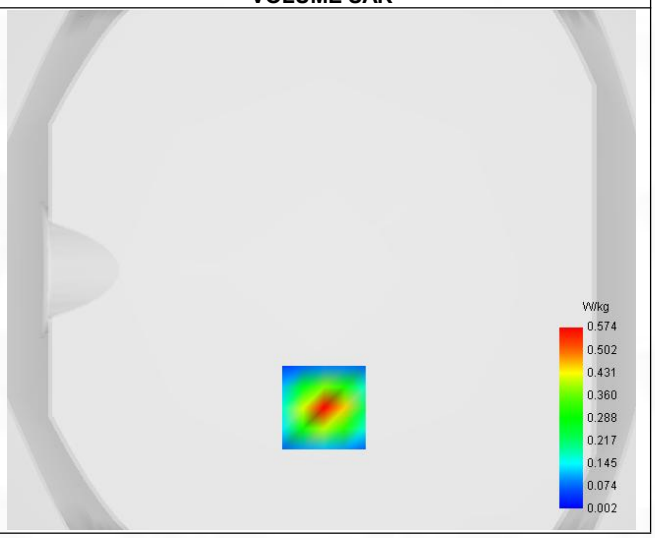
A. Experimental conditions.

Probe	SN 04/22 EPGO366
ConvF	1.68
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	Band 5 (850)
Channels	Middle (4182)
Signal	WCDMA
Mode	Release 99
Connection Type	RMC, 12.2 kbps

B. Permitivity

Frequency (MHz)	836.400
Relative permitivity (real part)	43.672
Relative permitivity (imaginary part)	19.623
Conductivity (S/m)	0.912

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=1.00, Y=-53.00 ; SAR Peak: 0.96 W/kg

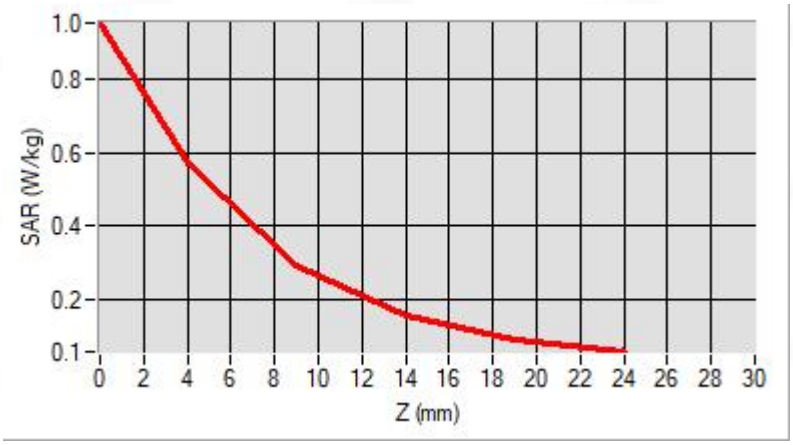
D. SAR 1g & 10g

SAR 10g (W/Kg)	0.236
SAR 1g (W/Kg)	0.515
Variation (%)	3.970
Horizontal validation criteria: minimum distance (mm)	8.236
Vertical validation criteria: SAR ratio M2/M1 (%)	51.05%

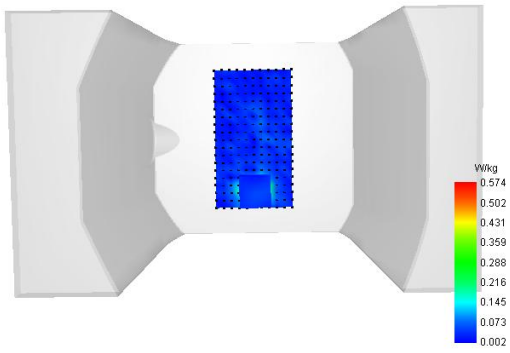
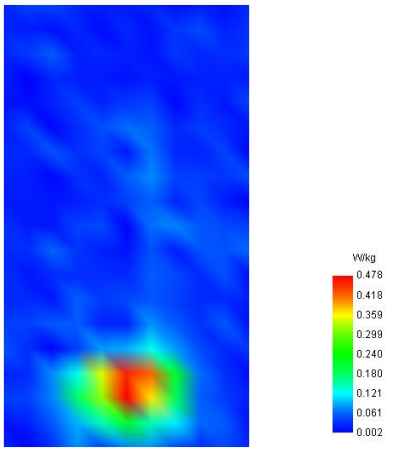
E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.957	0.574	0.293	0.153	0.089

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China



F. 3D Image

3D screen shot	Hot spot position
	

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

4-Body with back position in dist. 0mm on Channel 19100 in LTE band 2

SAR Measurement at LTE band 2 (Body, Validation Plane)

Date of measurement: 6/6/2024

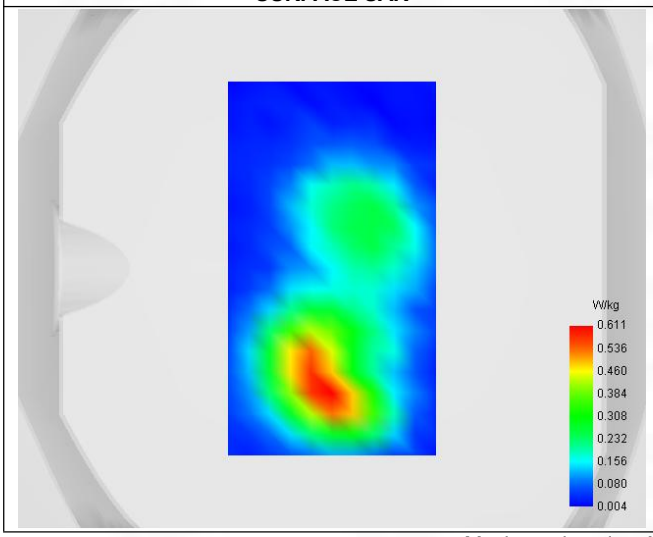
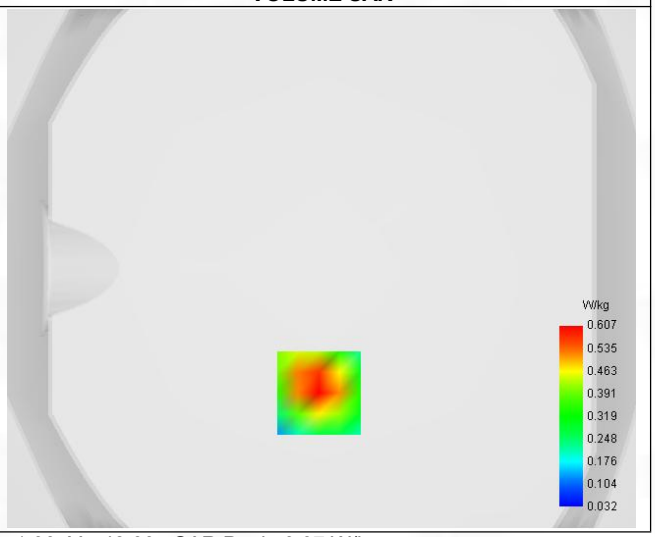
A. Experimental conditions.

Probe	SN 04/22 EPGO366
ConvF	2.07
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 2
Channels	Higher (19100)
Signal	LTE FDD
Cell Bandwidth	20 Mhz
Modulation	SC-OFDM - QPSK
RB offset	99
RB size	1

B. Permitivity

Frequency (MHz)	1908.910
Relative permitivity (real part)	39.867
Relative permitivity (imaginary part)	13.379
Conductivity (S/m)	1.416

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-1.00, Y=-48.00 ; SAR Peak: 0.97 W/kg

D. SAR 1g & 10g

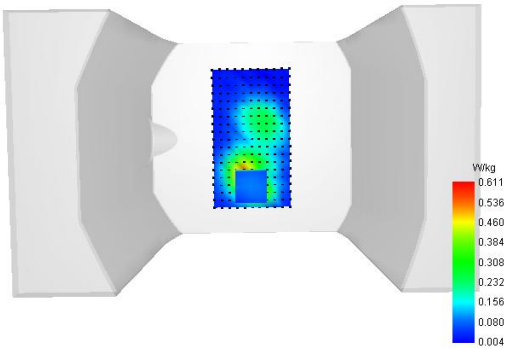
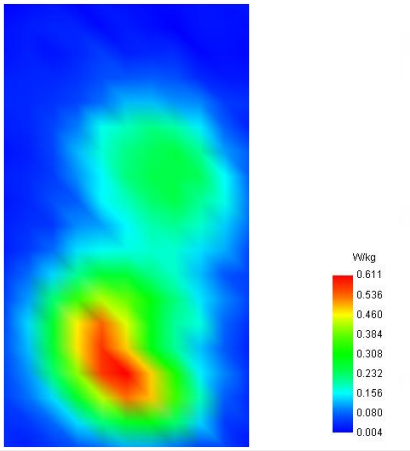
SAR 10g (W/Kg)	0.324
SAR 1g (W/Kg)	0.580
Variation (%)	-1.410
Horizontal validation criteria: minimum distance (mm)	9.454
Vertical validation criteria: SAR ratio M2/M1 (%)	56.84%

E. Z Axis Scan

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.949	0.607	0.345	0.205	0.135

F. 3D Image

3D screen shot	Hot spot position
	

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

5-Body with back position in dist. 0mm on Channel 20175 in LTE band 4

SAR Measurement at LTE band 4 (Body, Validation Plane)

Date of measurement: 5/6/2024

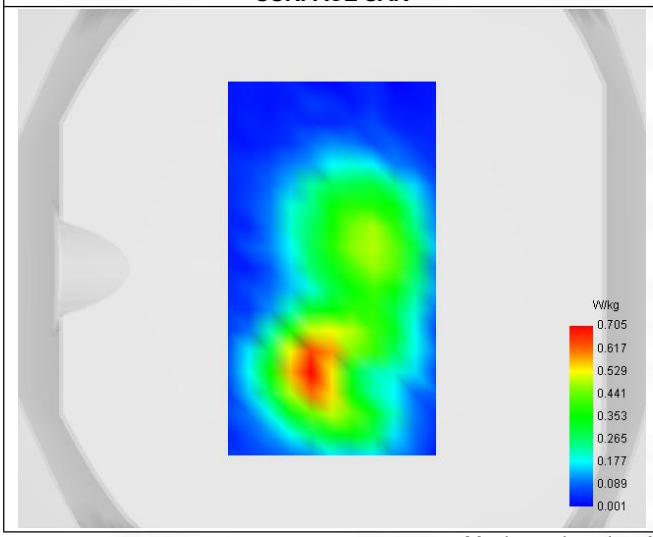
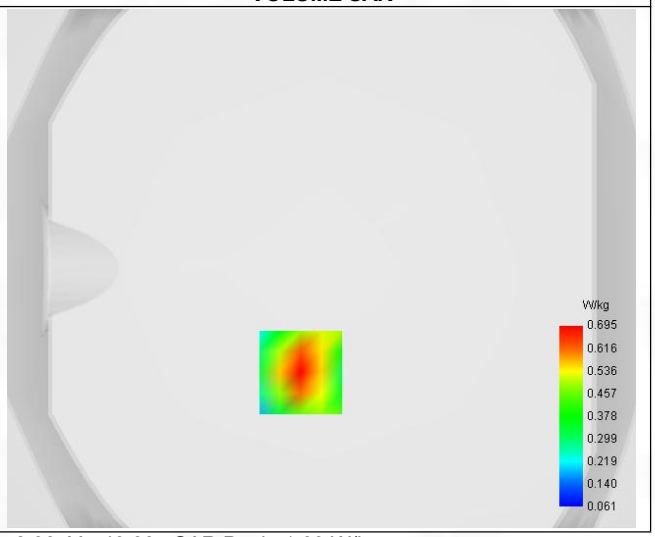
A. Experimental conditions.

Probe	SN 04/22 EPGO366
ConvF	1.79
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 4
Channels	Middle (20175)
Signal	LTE FDD
Cell Bandwidth	20 Mhz
Modulation	SC-OFDM - QPSK
RB offset	0
RB size	1

B. Permitivity

Frequency (MHz)	1723.590
Relative permitivity (real part)	40.029
Relative permitivity (imaginary part)	14.518
Conductivity (S/m)	1.330

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-8.00, Y=-40.00 ; SAR Peak: 1.09 W/kg

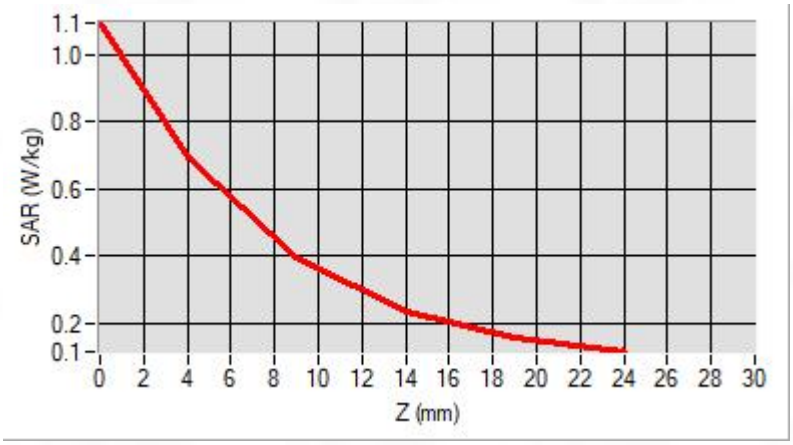
D. SAR 1g & 10g

SAR 10g (W/Kg)	0.366
SAR 1g (W/Kg)	0.649
Variation (%)	-3.800
Horizontal validation criteria: minimum distance (mm)	9.284
Vertical validation criteria: SAR ratio M2/M1 (%)	56.40%

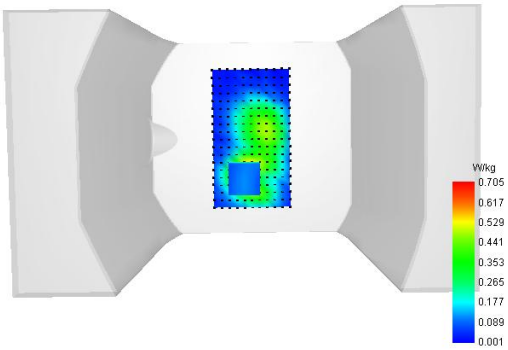
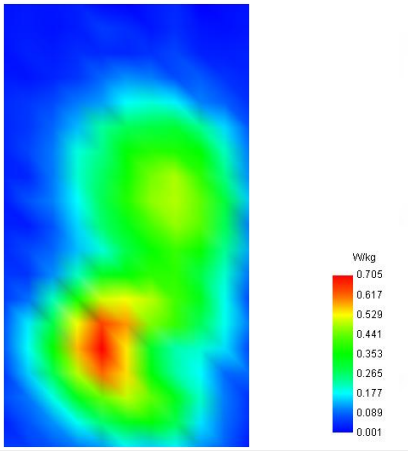
E. Z Axis Scan

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.093	0.695	0.392	0.234	0.158



F. 3D Image

3D screen shot	Hot spot position
	

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

6-Body with back position in dist. 0mm on Channel 20450 in LTE band 5

SAR Measurement at LTE band 5 (Body, Validation Plane)

Date of measurement: 5/6/2024

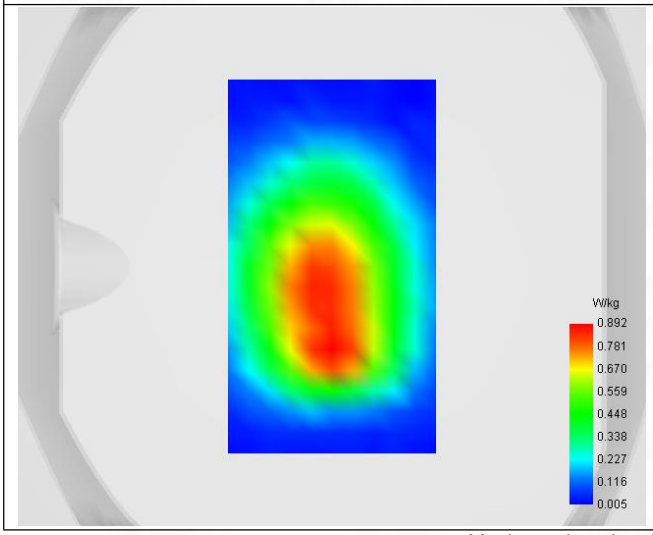
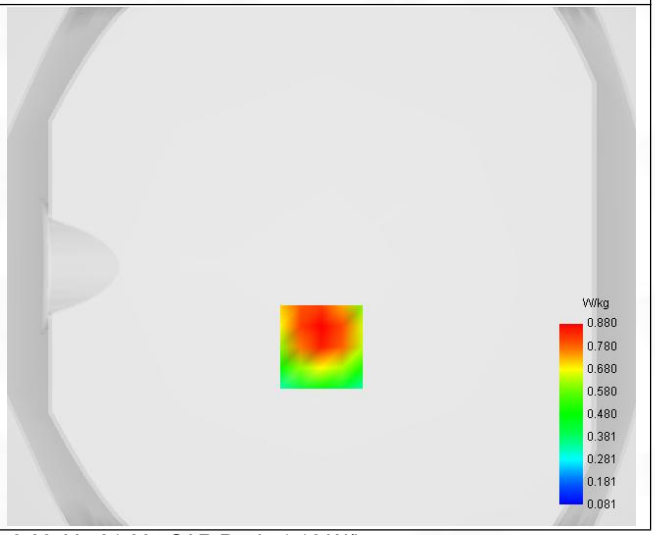
A. Experimental conditions.

Probe	SN 04/22 EPGO366
ConvF	1.68
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 5
Channels	Lower (20450)
Signal	LTE FDD
Cell Bandwidth	10 Mhz
Modulation	SC-OFDM - QPSK
RB offset	0
RB size	1

B. Permitivity

Frequency (MHz)	824.590
Relative permitivity (real part)	41.458
Relative permitivity (imaginary part)	19.731
Conductivity (S/m)	0.869

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=-31.00 ; SAR Peak: 1.16 W/kg

D. SAR 1g & 10g

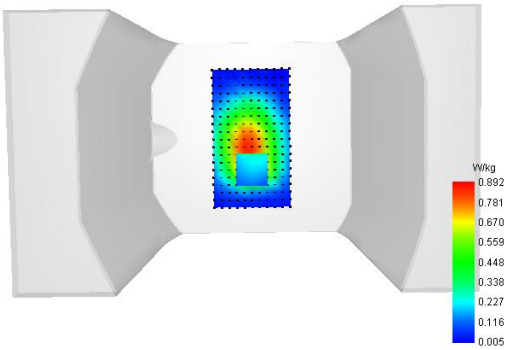
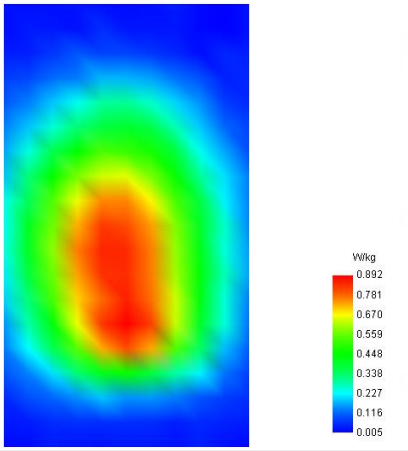
SAR 10g (W/Kg)	0.468
SAR 1g (W/Kg)	0.728
Variation (%)	-2.380
Horizontal validation criteria: minimum distance (mm)	8.525
Vertical validation criteria: SAR ratio M2/M1 (%)	53.98%

E. Z Axis Scan

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	2.545	0.880	0.475	0.460	0.234

F. 3D Image

3D screen shot	Hot spot position
	

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

7-Body with back position in dist. 0mm on Channel 21100 in LTE band 7

SAR Measurement at LTE band 7 (Body, Validation Plane)

Date of measurement: 12/6/2024

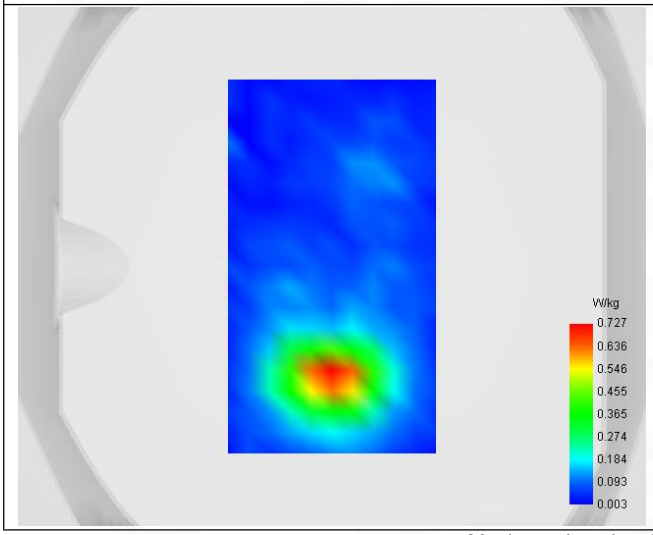
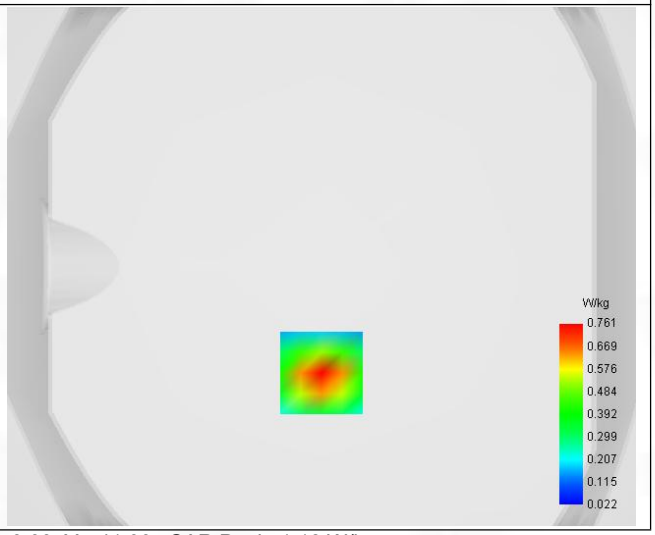
A. Experimental conditions.

Probe	SN 04/22 EPGO366
ConvF	2.08
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 7
Channels	Middle (21100)
Signal	LTE FDD
Cell Bandwidth	20 Mhz
Modulation	SC-OFDM - QPSK
RB offset	99
RB size	1

B. Permitivity

Frequency (MHz)	2543.910
Relative permitivity (real part)	38.955
Relative permitivity (imaginary part)	12.933
Conductivity (S/m)	1.910

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=-41.00 ; SAR Peak: 1.18 W/kg

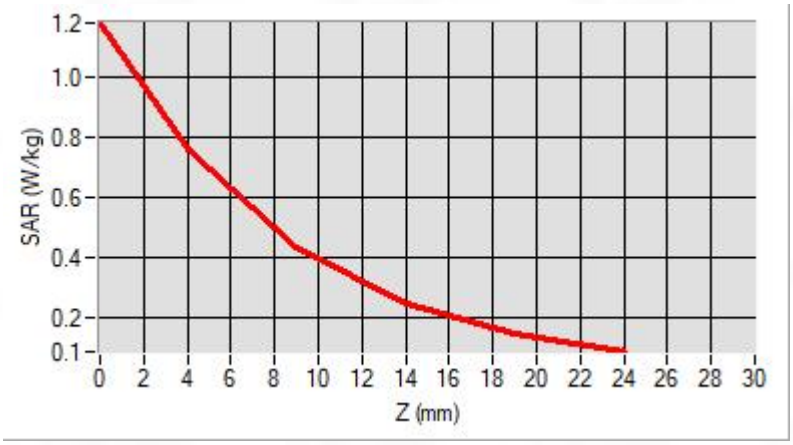
D. SAR 1g & 10g

SAR 10g (W/Kg)	0.367
SAR 1g (W/Kg)	0.713
Variation (%)	-1.930
Horizontal validation criteria: minimum distance (mm)	8.794
Vertical validation criteria: SAR ratio M2/M1 (%)	56.77%

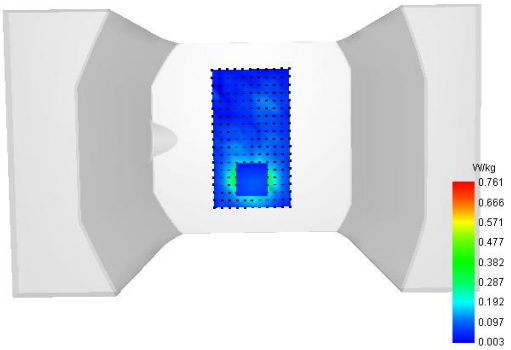
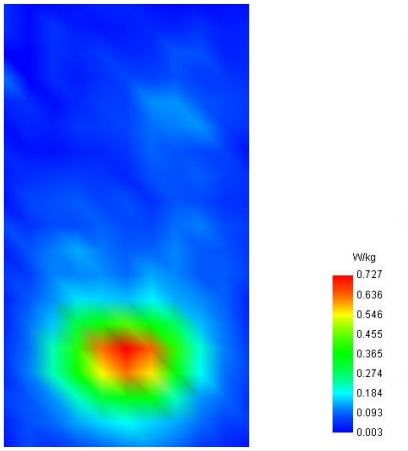
E. Z Axis Scan

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.176	0.761	0.432	0.248	0.149



F. 3D Image

3D screen shot	Hot spot position
	

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

8-Body with back position in dist. 0mm on Channel 38150 in LTE band 38

SAR Measurement at LTE band 38 (Body, Validation Plane)

Date of measurement: 12/6/2024

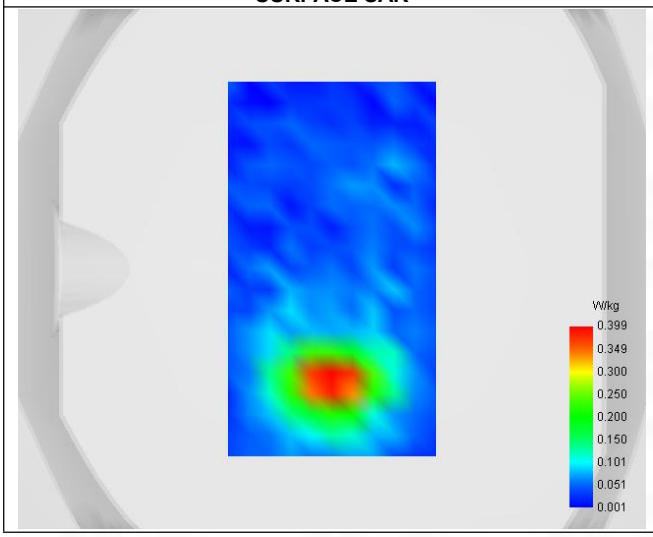
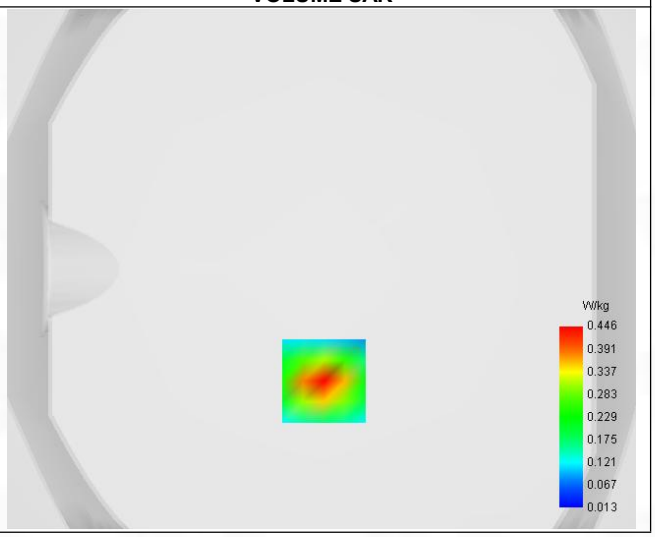
A. Experimental conditions.

Probe	SN 04/22 EPGO366
ConvF	2.08
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 38
Channels	Higher (38150)
Signal	LTE TDD
Cell Bandwidth	20 Mhz
Modulation	SC-OFDM - QPSK
RB offset	99
RB size	1
Subframe configuration	0
Special subframe configuration	0
Cyclic prefix	Normal
Duty Cycle (%)	0.61

B. Permitivity

Frequency (MHz)	2618.910
Relative permitivity (real part)	38.858
Relative permitivity (imaginary part)	12.716
Conductivity (S/m)	1.990

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=1.00, Y=-43.00 ; SAR Peak: 0.69 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.218
SAR 1g (W/Kg)	0.416
Variation (%)	1.970
Horizontal validation criteria: minimum distance (mm)	9.256

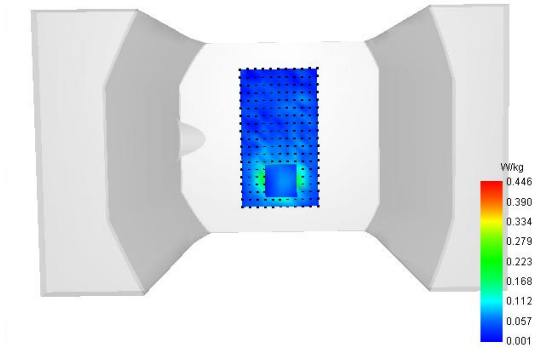
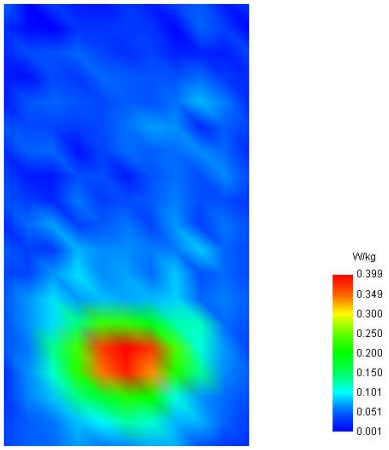
BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

Vertical validation criteria: SAR ratio M2/M1 (%)	57.17%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.693	0.446	0.255	0.155	0.105

F. 3D Image

3D screen shot	Hot spot position
	

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

9-Body with back position in dist. 0mm on Channel 41140 in LTE band 41

SAR Measurement at LTE band 41 (Body, Validation Plane)

Date of measurement: 12/6/2024

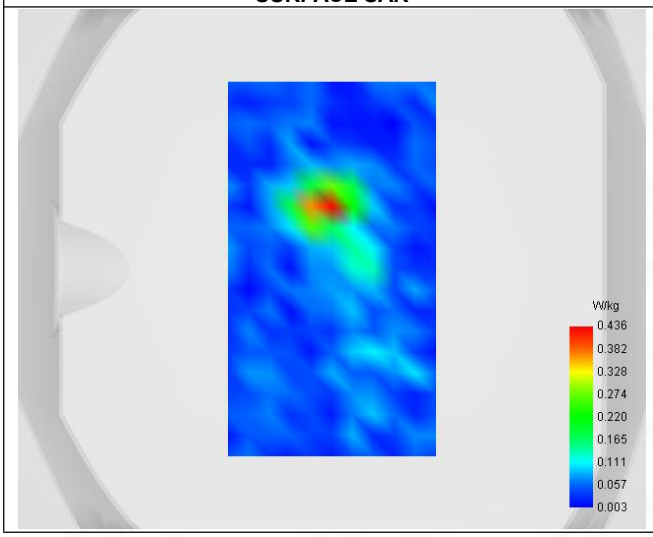
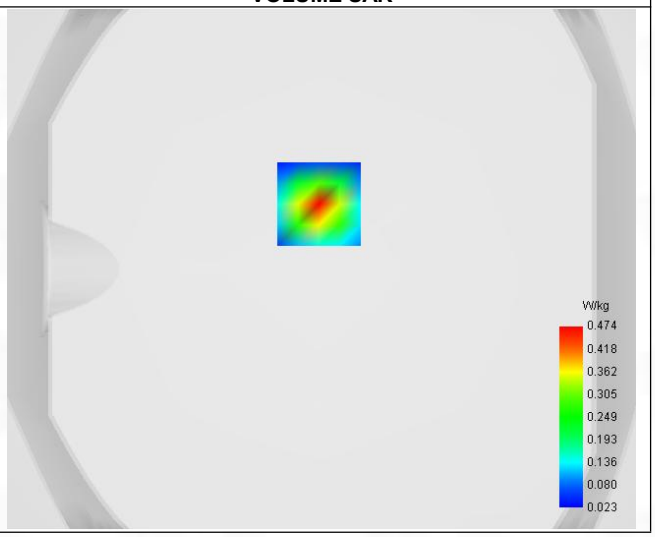
A. Experimental conditions.

Probe	SN 04/22 EPGO366
ConvF	2.08
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 41
Channels	Higher (41140)
Signal	LTE TDD
Cell Bandwidth	20 Mhz
Modulation	SC-OFDM - QPSK
RB offset	0
RB size	1
Subframe configuration	0
Special subframe configuration	0
Cyclic prefix	Normal
Duty Cycle (%)	0.61

B. Permitivity

Frequency (MHz)	2645.000
Relative permitivity (real part)	38.828
Relative permitivity (imaginary part)	12.752
Conductivity (S/m)	2.017

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-1.00, Y=25.00 ; SAR Peak: 0.87 W/kg

D. SAR 1g & 10g

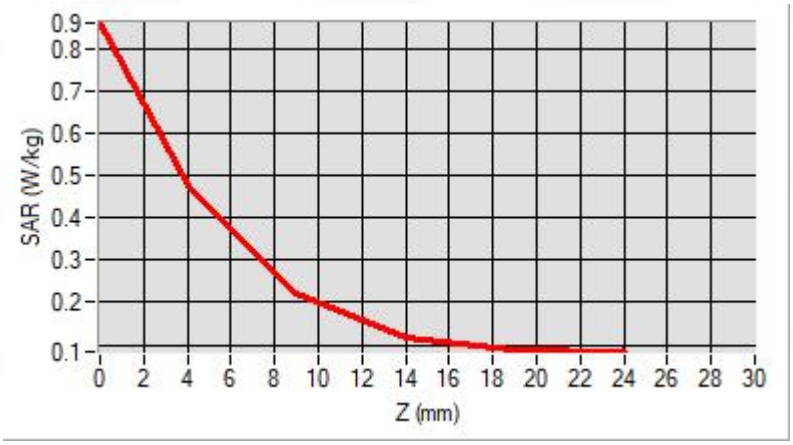
SAR 10g (W/Kg)	0.200
SAR 1g (W/Kg)	0.433
Variation (%)	-3.420
Horizontal validation criteria: minimum distance (mm)	8.636

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

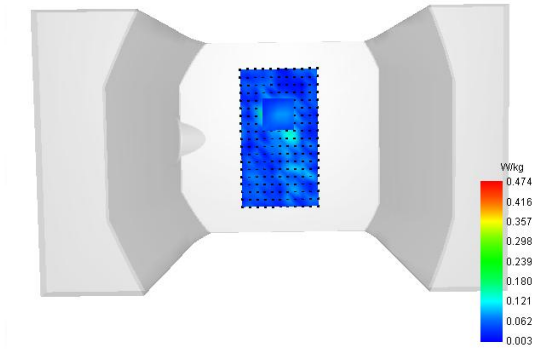
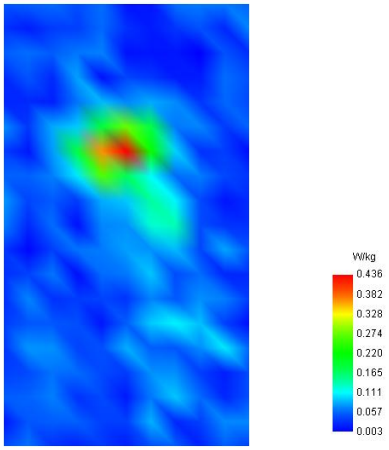
Vertical validation criteria: SAR ratio M2/M1 (%)	46.41%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.859	0.474	0.220	0.118	0.088



F. 3D Image

3D screen shot	Hot spot position
	

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

10-Body with back position in dist. 0mm on Channel 1 in IEEE 802.11b ISM

SAR Measurement at IEEE 802.11b ISM (Body, Validation Plane)

Date of measurement: 11/6/2024

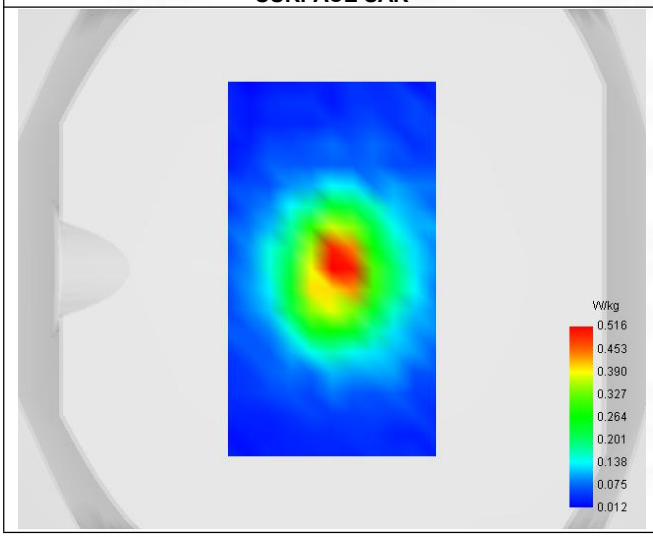
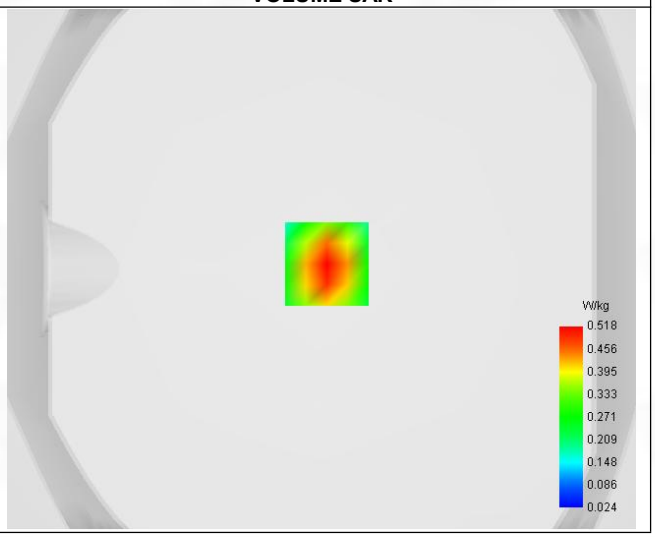
A. Experimental conditions.

Probe	SN 04/22 EPGO366
ConvF	2.12
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	IEEE 802.11b ISM
Channels	Lower (1)
Signal	IEEE 802.11

B. Permitivity

Frequency (MHz)	2412.000
Relative permitivity (real part)	39.135
Relative permitivity (imaginary part)	13.343
Conductivity (S/m)	1.782

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=2.00, Y=2.00 ; SAR Peak: 0.90 W/kg

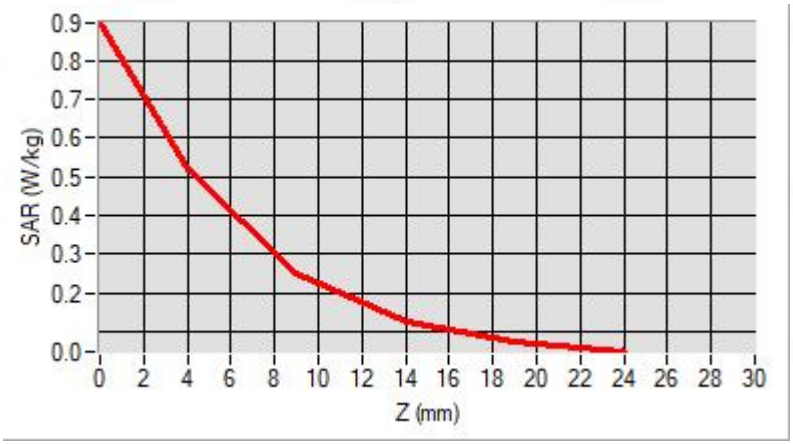
D. SAR 1g & 10g

SAR 10g (W/Kg)	0.265
SAR 1g (W/Kg)	0.490
Variation (%)	-2.920
Horizontal validation criteria: minimum distance (mm)	8.697
Vertical validation criteria: SAR ratio M2/M1 (%)	48.46%

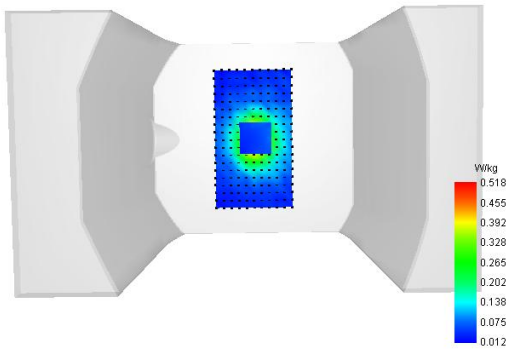
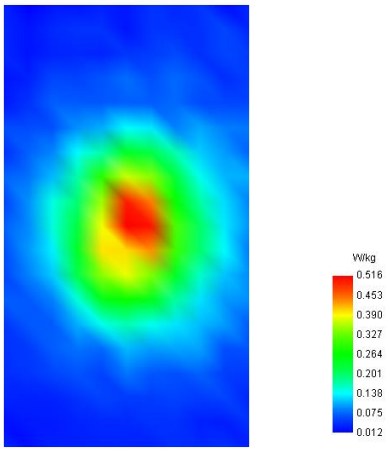
E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.897	0.518	0.251	0.126	0.073

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China



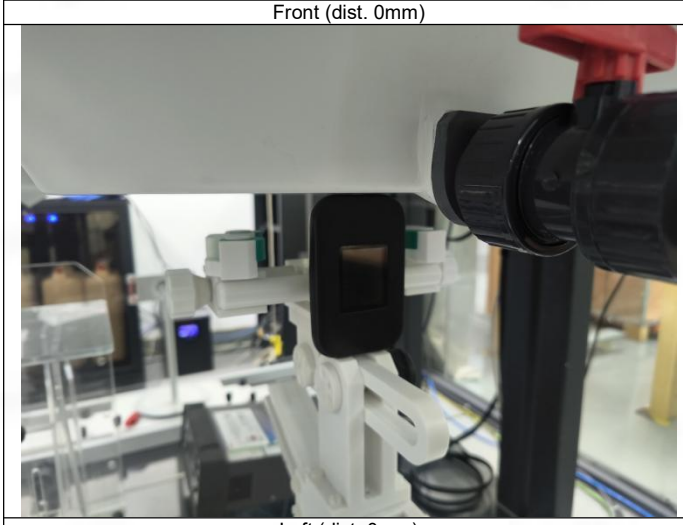
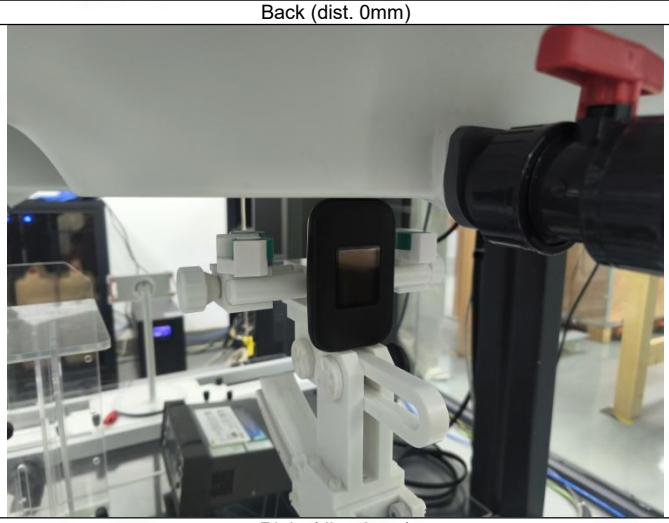
F. 3D Image

3D screen shot	Hot spot position
	

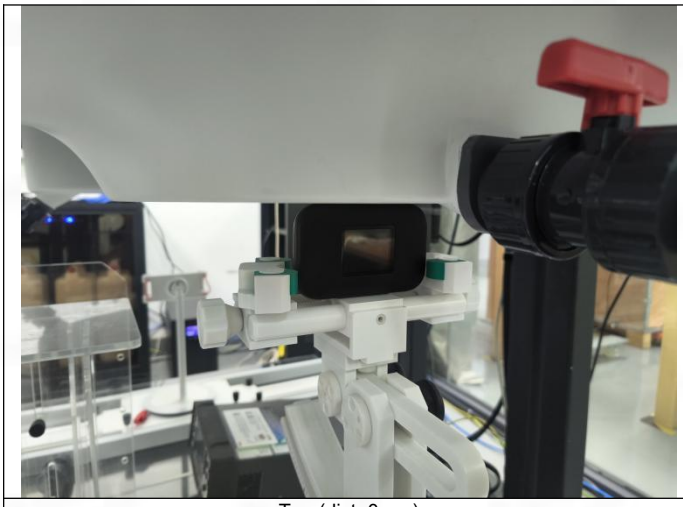
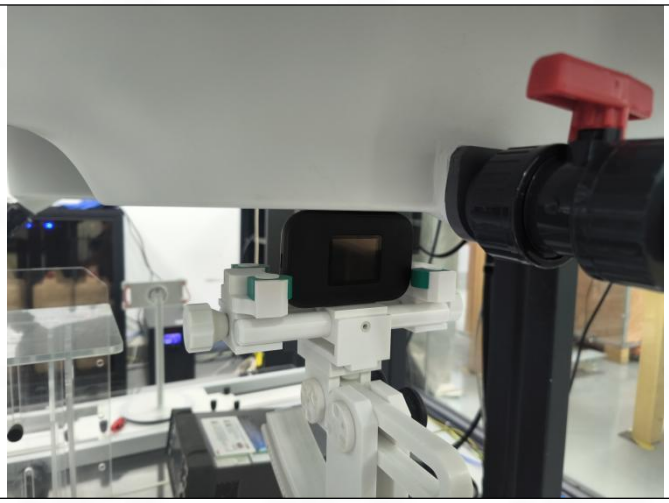
BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

ANNEX D SAR Test Setup Photos

Reference Photo: simulation liquid depth 15cm


Reference Photos	
	
Front (dist. 0mm)	Back (dist. 0mm)
	
Left (dist. 0mm)	Right (dist. 0mm)

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

	
Top (dist. 0mm)	Bottom (dist. 0mm)

ANNEX E EUT External and Internal Photos

Please refer to RF Report.

ANNEX F Calibration Information

Please refer to the document “Calibration.pdf”.

BTF Testing Lab (Shenzhen) Co., Ltd.

F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

www.btf-lab.com

--END OF REPORT--